







DAC63004, DAC53004 SLASEX2 - APRIL 2021

# DACx3004 12-Bit and 10-Bit, Ultra-Low-Power, Quad Voltage and Current Output Smart DACs With Auto-Detected I<sup>2</sup>C, PMBus™, or SPI

### 1 Features

- Programmable voltage or current outputs with flexible configuration:
  - Voltage outputs:
    - 1 LSB INL and DNL (10-bit)
    - Gains of 1x, 1.5x, 2x, 3x, and 4x
  - Current outputs:
    - 1 LSB INL and DNL (8-bit)
    - Unipolar and bipolar output range options from 25  $\mu$ A to 250  $\mu$ A
- 50 μA/channel quiescent current in voltage-output
- Programmable comparator mode for all channels
- High-impedance output when VDD is off
- High-impedance and resistive pulldown powerdown modes
- 25-MHz SPI-compatible interface
- Automatically detected I<sup>2</sup>C, PMBus<sup>™</sup>, or SPI interface
  - 1.62-V V<sub>IH</sub> with V<sub>DD</sub> = 5.5 V
- General-purpose input/output (GPIO) configurable as multiple functions
- Predefined waveform generation: sine wave, triangular, sawtooth
- User-programmable nonvolatile memory (NVM)
- Internal, external, or power-supply as reference
- Wide operating range:
  - Power supply: 1.8 V to 5.5 V
  - Temperature range: –40°C to +125°C
- Tiny package: 16-pin WQFN (3 mm × 3 mm)

### VRE VDD INT MUX NVM A0/SDI SCL/SYNC DAC OUT0-3 SDA/SCLK GPIO/SDO FB0-3 Function Channel 0-3

**Simplified Block Diagram** 

# 2 Applications

- Land mobile radio
- Pulse oximeter
- Optical module
- Standard notebook PC

# 3 Description

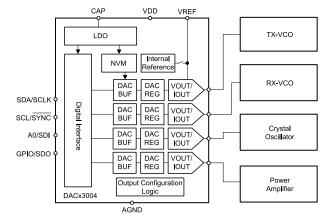
The 12-bit DAC63004 and 10-bit DAC53004 (DACx3004) are a pin-compatible family of ultralow-power, quad-channel, buffered, voltage-output and current-output smart digital-to-analog converters (DACs). The DAC outputs are capable of both voltage and current output. These DACx3004 support Hi-Z power-down mode and Hi-Z output during poweroff condition. The DAC outputs provide a forcesense option for use as a programmable comparator and current sink. The multifunction GPIO, function generation, and NVM enable these smart DACs for processor-less applications and design reuse. These devices also have an automatically detected I<sup>2</sup>C, PMBus, or SPI interface and an internal reference.

The feature set combined with the tiny package and ultra-low-power make these smart DACs an excellent choice for applications such as land mobile radio, pulseoximeter, notebook PCs, and other batteryoperated applications for biasing, calibration, and waveform generation.

#### **Device Information**

| PART NUMBER | PACKAGE <sup>(1)</sup> | BODY SIZE (NOM)   |  |  |
|-------------|------------------------|-------------------|--|--|
| DACx3004    | WQFN (16)              | 3.00 mm x 3.00 mm |  |  |

For all available packages, see the orderable addendum at the end of the data sheet.



DACx3004 for Biasing in Land Mobile Radio



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# 4 Revision History

| DATE       | REVISION | NOTES           |
|------------|----------|-----------------|
| April 2021 | *        | Initial Release |



# **5 Pin Configuration and Functions**

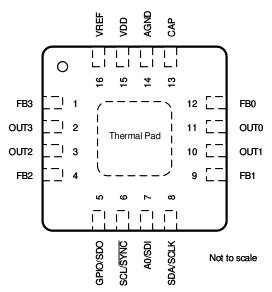


Figure 5-1. RTE Package, 16-pin WQFN, Top View

**Table 5-1. Pin Functions** 

|     | PIN         |              | DECORPORA  |  |  |  |
|-----|-------------|--------------|--|--|--|--|
| NO. | NAME        | TYPE         | DESCRIPTION  |  |  |  |
| 1   | FB3         | Input        | Voltage feedback pin for channel 3. In voltage-output mode, connect to OUT3 for closed-loop amplifier output. In current-output mode, keep the FB3 pin unconnected to minimize leakage current.  |  |  |  |
| 2   | OUT3        | Output       | Analog output voltage from DAC channel 3.  |  |  |  |
| 3   | OUT2        | Output       | Analog output voltage from DAC channel 2.  |  |  |  |
| 4   | FB2         | Input        | Voltage feedback pin for channel 2. In voltage-output mode, connect to OUT2 for closed-loop amplifier output. In current-output mode, keep the FB2 pin unconnected to minimize leakage current.  |  |  |  |
| 5   | GPIO/SDO    | Input/Output | General-purpose input/output configurable as LDAC, PD, STATUS, SDO, and PROTECT. In STATUS and SDO functions, connect the pin to the IO voltage with an external pullup resistor.  |  |  |  |
| 6   | SCL/SYNC    | Output       | I <sup>2</sup> C serial interface clock or SPI chip select input. This pin must be connected to the IO voltage using an external pullup resistor.  |  |  |  |
| 7   | A0/SDI      | Input        | Address configuration pin for I <sup>2</sup> C or serial data input for SPI. In A0 function, connect this pin to VDD, AGND, SDA, or SCL for address configuration. In SDI function, this pin need not be pulled up or pulled down.   |  |  |  |
| 8   | SDA/SCLK    | Input/Output | Bidirectional I <sup>2</sup> C serial data bus or SPI clock input. This pin must be connected to the IO voltage using an external pullup resistor in the I <sup>2</sup> C mode.  |  |  |  |
| 9   | FB1         | Input        | Voltage feedback pin for channel 1. In voltage-output mode, connect to OUT1 for closed-loop amplifier output. In current-output mode, keep the FB1 pin unconnected to minimize leakage current.  |  |  |  |
| 10  | OUT1        | Output       | Analog output voltage from DAC channel 1.  |  |  |  |
| 11  | OUT0        | Output       | Analog output voltage from DAC channel 0.  |  |  |  |
| 12  | FB0         | Input        | Voltage feedback pin for channel 0. In voltage-output mode, connect to OUT0 for closed-loop amplifier output. In current-output mode, keep the FB0 pin unconnected to minimize leakage current.  |  |  |  |
| 13  | CAP         | Power        | External bypass capacitor for the internal LDO. Connect a capacitor (approximately 1.5 μF) between CAP and AGND.   |  |  |  |
| 14  | AGND        | Ground       | Ground reference point for all circuitry on the device.  |  |  |  |
| 15  | VDD         | Power        | Supply voltage: 1.8 V to 5.5 V.  |  |  |  |
| 16  | VREF        | Power        | External reference input. Connect a capacitor (approximately 0.1 µF) between VREF and AGND. Use a pullup resistor to VDD when the external reference is not used. This pin must not ramp up before VDD. In case an external reference is used, make sure the reference ramps up after VDD. |  |  |  |
| _   | Thermal Pad | Ground       | Connect the thermal pad to AGND.   |  |  |  |



# **6 Specifications**

# **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

|                  |   | М  | IN MAX         | UNIT |
|------------------|---|----|----------------|------|
| V <sub>DD</sub>  | Supply voltage, V <sub>DD</sub> to A <sub>GND</sub> | -( | 0.3 6          | V    |
|                  | Digital inputs to A <sub>GND</sub>                  | -( | $V_{DD} + 0.3$ | V    |
|                  | CAP to A <sub>GND</sub>                             | -( | 0.3 1.65       | V    |
|                  | V <sub>FBX</sub> to A <sub>GND</sub>                | -( | $V_{DD} + 0.3$ | V    |
|                  | V <sub>OUTX</sub> to A <sub>GND</sub>               | -( | $V_{DD} + 0.3$ | V    |
|                  | Current into any pin except the OUTx pins           | _  | 10 10          | mA   |
| TJ               | Junction temperature                                | _  | 40 150         | °C   |
| T <sub>stg</sub> | Storage temperature                                 | _  | 65 150         | °C   |

1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

# 6.2 ESD Ratings

|                    |                         |  | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
|                    |                         | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>              | ±2000 |      |
| V <sub>(ESD)</sub> | Electrostatic discharge | Charged device model (CDM), per JEDEC specification JESD22-C101, pins TBD <sup>(2)</sup> | ±750  | ] v  |
|                    |                         | Charged device model (CDM), per JEDEC specification JESD22-C101, pins TBD <sup>(2)</sup> | ±500  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

|                 |   | MIN  | NOM | MAX | UNIT |
|-----------------|---|------|-----|-----|------|
| $V_{DD}$        | Positive supply voltage to ground (A <sub>GND</sub> )       | 1.71 |     | 5.5 | V    |
| V <sub>IH</sub> | Digital input high voltage, 1.7 V < V <sub>DD</sub> ≤ 5.5 V | 1.62 |     |     | V    |
| V <sub>IL</sub> | Digital input low voltage                                   |      |     | 0.4 | V    |
| T <sub>A</sub>  | Ambient temperature   | -40  |     | 125 | °C   |

### **6.4 Thermal Information**

|                       |  | DACx3004   |      |
|-----------------------|--|------------|------|
|                       | THERMAL METRIC <sup>(1)</sup>                | RTE (WQFN) | UNIT |
|                       |  | 16 PINS    |      |
| R <sub>0JA</sub>      | Junction-to-ambient thermal resistance       | 49         | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 50         | °C/W |
| $R_{\theta JB}$       | Junction-to-board thermal resistance         | 24.1       | °C/W |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 1.1        | °C/W |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 24.1       | °C/W |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | 8.7        | °C/W |

(1) For information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



# 6.5 Electrical Characteristics - Voltage Output

all minimum/maximum specifications at  $T_A$  =  $-40^{\circ}$ C to +125°C and typical specifications at  $T_A$  = 25°C, 1.8 V ≤  $V_{DD}$  ≤ 5.5 V, DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ( $R_L$  = 5 k $\Omega$  to AGND) and capacitive load ( $C_L$  = 200 pF to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

|            | PARAMETER   | TEST CONDITIONS  | MIN   | TYP     | MAX      | UNIT   |
|------------|---|--|-------|---------|----------|--------|
| STAT       | TIC PERFORMANCE   |  |       |         |          |        |
|            | Resolution  | DAC63004   | 12    |         |          | Bits   |
|            | Resolution  | DAC53004   | 10    | ,       |          | Bits   |
| NL         | Relative accuracy <sup>(1)</sup>                        | DAC63004   | -4    |         | 4        | LSB    |
| NL         | Relative accuracy <sup>(1)</sup>                        | DAC53004   | -1    |         | 1        | LSB    |
| DNL        | Differential nonlinearity <sup>(1)</sup>                |  | -1    |         | 1        | LSB    |
|            |   | Code 0d into DAC, external reference, V <sub>DD</sub> = 5.5 V  |       | 6       | 12       |        |
|            | Zero-code error <sup>(4)</sup>                          | Code 0d into DAC, internal V <sub>REF</sub> , gain = 4x, V <sub>DD</sub> = 5.5 V   |       | 6       | 15       | mV     |
|            | Zero-code error temperature coefficient <sup>(4)</sup>  |  |       | ±10     |          | μV/°C  |
|            | Offset error <sup>(4)</sup>                             | $1.8 \text{ V} \le \text{V}_{\text{DD}} \le 2.7 \text{ V}, \text{V}_{\text{FB}} \text{ pin shorted to V}_{\text{OUT}}$                                     | -0.75 | 0.3     | 0.75     | %FSR   |
|            | Offset efforty  | $2.7 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{ V}_{\text{FB}} \text{ pin shorted to V}_{\text{OUT}}$                                    | -0.5  | 0.25    | 0.5      | 70F3K  |
|            | Offset-error temperature coefficient <sup>(4)</sup>     |  |       | ±0.0003 |          | %FSR/° |
|            | Gain error <sup>(4)</sup>                               |  | -0.5  | 0.25    | 0.5      | %FSR   |
|            | Gain-error temperature coefficient <sup>(4)</sup>       |  |       | ±0.0008 |          | %FSR/° |
|            | [   | 1.8 V ≤ V <sub>DD</sub> < 2.7 V, program full code into DAC  | -1    |         | 1        | 0/ 505 |
|            | Full scale error <sup>(4)</sup>                         | 2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V, program full code into DAC  | -0.5  |         | 0.5      | %FSR   |
|            | Full-scale-error temperature coefficient <sup>(4)</sup> |  |       | ±0.0008 |          | %FSR/° |
| DUT        | PUT CHARACTERISTICS                                     |  |       |         | '        |        |
|            | Output voltage  | Reference tied to V <sub>DD</sub>  | 0     |         | $V_{DD}$ | V      |
|            | 0   | R <sub>L</sub> = Infinite, phase margin = 30°  |       |         | 200      |        |
| CL         | Capacitive load <sup>(2)</sup>                          | $R_L$ = 5 kΩ, phase margin = 30°   |       |         | 1000     | - pF   |
|            |   | $V_{DD}$ = 1.8 V, full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$  |       | 15      |          |        |
|            | Short-circuit current                                   | $V_{DD}$ = 2.7 V, full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$  |       | 50      |          | mA     |
|            |   | $V_{DD}$ = 5.5 V, full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$  |       | 60      |          |        |
|            |   | To $V_{DD}$ (DAC output unloaded, internal reference = 1.21 V), $V_{DD} \ge 1.21 \times \text{gain} + 0.2 \text{ V}$                                       | 0.2   |         |          | V      |
|            | Output-voltage headroom <sup>(2)</sup>                  | To $V_{DD}$ (DAC output unloaded, reference tied to $V_{DD}$ )   | 0.8   |         |          |        |
|            |   | To $V_{DD}$ ( $I_{LOAD}$ = 10 mA at $V_{DD}$ = 5.5 V, $I_{LOAD}$ = 3 mA at $V_{DD}$ = 2.7 V, $I_{LOAD}$ = 1 mA at $V_{DD}$ = 1.8 V), DAC code = full scale | 10    |         |          | %FSR   |
| <u>'</u> 0 | V <sub>FB</sub> dc output impedance <sup>(3)</sup>      | DAC output enabled, DAC reference tied to VDD (gain = 1x) or internal reference (gain = 1.5x or 2x)  | 400   | 500     | 600      | kΩ     |
|            |   | DAC output enabled, internal V <sub>REF</sub> , gain = 3x or 4x  | 325   | 400     | 485      | L      |
|            | Power supply rejection ratio (dc)                       | Internal V <sub>REF</sub> , gain = 2x, DAC at midscale;<br>V <sub>DD</sub> = 5 V ±10%  |       | 0.25    |          | mV/V   |
|            |   |  |       |         |          |        |



# 6.5 Electrical Characteristics - Voltage Output (continued)

all minimum/maximum specifications at  $T_A$  =  $-40^{\circ}$ C to +125°C and typical specifications at  $T_A$  = 25°C, 1.8 V ≤  $V_{DD}$  ≤ 5.5 V, DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ( $R_L$  = 5 k $\Omega$  to AGND) and capacitive load ( $C_L$  = 200 pF to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

|                   | PARAMETER  | TEST CONDITIONS  | MIN | TYP  | MAX | UNIT               |
|-------------------|--|--|-----|------|-----|--------------------|
| DYN               | AMIC PERFORMANCE                                 |  |     |      |     |                    |
|                   |  | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V <sub>DD</sub> = 5.5 V  |     | 20   |     |                    |
| t <sub>sett</sub> | Output voltage settling time                     | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V <sub>DD</sub> = 5.5 V, internal V <sub>REF</sub> , gain = 4x     |     | 25   |     | μs                 |
|                   | Slew rate  | V <sub>DD</sub> = 5.5 V  |     | 0.3  |     | V/µs               |
|                   | Power on glitch magnitude                        | At startup (DAC output disabled), $R_L = 5 \text{ k}\Omega$ , $C_L = 200 \text{ pF}$   |     | 75   |     | mV                 |
|                   |  | At startup (DAC output disabled), $R_L$ = 100 k $\Omega$   |     | 200  |     |                    |
|                   | Output enable glitch magnitude                   | DAC output disabled to enabled (DAC registers at zero scale, $R_L$ = 100 $k\Omega$   |     | 250  |     | mV                 |
|                   | Output noise voltage (peak to peak)              | 0.1 Hz to 10 Hz, DAC at midscale, V <sub>DD</sub> = 5.5 V  |     | 50   |     |                    |
| Vn                |  | Internal V <sub>REF</sub> , gain = 4x, 0.1 Hz to 10 Hz, DAC at midscale, V <sub>DD</sub> = 5.5 V                             |     | 90   |     | $\mu V_{PP}$       |
|                   |  | Measured at 1 kHz, DAC at midscale, V <sub>DD</sub> = 5.5 V  |     | 0.35 |     |                    |
|                   | Output noise density                             | Internal V <sub>REF</sub> , gain = 4x, measured at 1 kHz, DAC at midscale, V <sub>DD</sub> = 5.5 V                           |     | 0.9  |     | μV/√ <del>Hz</del> |
|                   | Power supply rejection ratio (ac) <sup>(3)</sup> | Internal V <sub>REF</sub> , gain = 4x, 200-mV 50 Hz or 60 Hz sine wave superimposed on power supply voltage, DAC at midscale |     | -68  |     | dB                 |
|                   | Code change glitch impulse                       | ±1 LSB change around mid code (including feedthrough)  |     | 10   |     | nV-s               |
|                   | Code change glitch impulse magnitude             | ±1 LSB change around mid code (including feedthrough)  |     | 15   |     | mV                 |
| POW               | VER  |  |     |      |     |                    |
| I <sub>DD</sub>   | Current flowing into VDD <sup>(4)</sup>          | Normal operation, DACs at full scale, digital pins static  |     | 35   | 50  | μA/ch              |
|                   |  |  |     |      |     |                    |

- (1) Measured with DAC output unloaded. For external reference and internal reference V<sub>DD</sub> ≥ 1.21 x gain + 0.2 V, between end-point codes: 32d to 4032d for 12-bit resolution, 8d to 1016d for 10-bit resolution, 2d to 254d for 8-bit resolution.
- (2) Specified by design and characterization, not production tested.
- (3) Specified with 200-mV headroom with respect to reference value when internal reference is used.
- (4) Measured with DAC output unloaded.



# 6.6 Electrical Characteristics - Current Output

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to +125°C and typical specifications at  $T_A = 25^{\circ}\text{C}$ , 1.8 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, ±250µA output range, and digital inputs at VDD or AGND (unless otherwise noted)

|                   | PARAMETER   | nputs at VDD or AGND (unless otherwise noted)  TEST CONDITIONS   | MIN | TYP  | MAX | UNIT               |
|-------------------|---|--|-----|------|-----|--------------------|
| STAT              | TIC PERFORMANCE                                     |  |     |      |     |                    |
|                   | Resolution  | All variants   | 8   |      |     | Bits               |
| INL               | Relative accuracy <sup>(1)</sup>                    |  | -1  |      | 1   | LSB                |
| DNL               | Differential nonlinearity <sup>(1)</sup>            |  | -1  |      | 1   | LSB                |
|                   | Offset error  | DAC output ranges: ±25μA, ±50μA, ±125μA, and ±250μA. Measured at mid-scale   |     | ±1   |     | %FSR               |
|                   | Gain error <sup>(4)</sup>                           | DAC output ranges: ±25μA, ±50μA, ±125μA, and ±250μA  |     | ±1.3 |     | %FSR               |
| OUT               | PUT CHARACTERISTICS                                 |  |     |      |     |                    |
|                   | Output compliance voltage <sup>(1)</sup>            | DAC output range: 0μΑ-25μΑ, To V <sub>DD</sub>   | 200 |      |     | mV                 |
|                   | Output compliance voltage <sup>(1)</sup>            | DAC output ranges: 0μΑ-50μΑ, 0μΑ-125μΑ, and 0μΑ-250μΑ, To V <sub>DD</sub>  | 400 |      |     | mV                 |
|                   | Output compliance voltage <sup>(1)</sup>            | DAC output ranges: -24μΑ-0μΑ, -48μΑ-0μΑ, -120μΑ-0μΑ, and -200μΑ-0μΑ, To V <sub>DD</sub>  | 400 |      |     | mv                 |
|                   | Output compliance voltage <sup>(1)</sup>            | DAC output ranges: ±25μA, ±50μA, ±125μA, and ±250μA, To V <sub>DD</sub> and to AGND  | 400 |      |     | mV                 |
| Zo                | I <sub>OUT</sub> dc output impedance <sup>(2)</sup> | DAC code = midscale, DAC output kept at V <sub>DD</sub> /2   | 100 |      |     | ΜΩ                 |
|                   | Power supply rejection ratio (dc)                   | DAC at midscale, Gain setting: 0μA-25μA, V <sub>DD</sub> changed from 4.5V to 5.5V   |     | 0.28 |     | LSB/V              |
| DYN               | AMIC PERFORMANCE                                    |  |     |      |     |                    |
| t <sub>sett</sub> | Output current settling time                        | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 1 LSB at 8-bit resolution, $V_{DD}$ = 5.5 V, common-mode voltage at OUTx pin is $V_{DD}/2$ |     | 100  |     | μs                 |
| V <sub>n</sub>    | Output noise current (peak to peak)                 | 0.1 Hz to 10 Hz, DAC at midscale,<br>V <sub>DD</sub> = 5.5 V, ±250µA output range  |     | 150  |     | nA <sub>PP</sub>   |
|                   | Output noise density                                | Measured at 1 kHz, DAC at midscale,<br>V <sub>DD</sub> = 5.5 V, ±250µA output range  |     | 1    |     | nA/√ <del>Hz</del> |
|                   | Power supply rejection ratio (ac) <sup>(3)</sup>    | Measured at ±250µA output range, 200-mV 50 Hz or 60 Hz sine wave superimposed on power supply voltage, DAC at midscale                       |     | TBD  |     | LSB/V              |
| POW               | /ER   |  |     |      |     |                    |
|                   | Load capacitor - CAP pin <sup>(2)</sup>             |  | 0.5 |      | 15  | μF                 |
|                   |   | Normal operation, DACs at mid scale, 0μA - 25μA output range, digital pins static  |     | 18   | 24  |                    |
|                   |   | Normal operation, DACs at mid scale, 0μA - 50μA output range, digital pins static  |     | 18   | 24  |                    |
|                   |   | Normal operation, DACs at mid scale, 0μA - 125μA output range, digital pins static   |     | 18   | 24  |                    |
| l                 | Current flowing into VDD <sup>(3)</sup>             | Normal operation, DACs at mid scale, 0μA - 250μA output range, digital pins static   |     | 18   | 24  | μΑ/ch              |
| I <sub>DD</sub>   | Current llowing into VDD(9)                         | Normal operation, DACs at mid scale, -24μA - 0μA output range, digital pins static   |     | 18   | 24  | μ, (ΟΙΙ            |
|                   |   | Normal operation, DACs at mid scale, -48μA - 0μA output range, digital pins static   |     | 18   | 24  |                    |
|                   |   | Normal operation, DACs at mid scale, -120μA - 0μA output range, digital pins static  |     | 18   | 24  |                    |
|                   |   | Normal operation, DACs at mid scale, -240μA - 0μA output range, digital pins static  |     | 18   | 24  |                    |



# 6.6 Electrical Characteristics - Current Output (continued)

all minimum/maximum specifications at  $T_A$  = -40°C to +125°C and typical specifications at  $T_A$  = 25°C, 1.8 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, ±250 $\mu$ A output range, and digital inputs at VDD or AGND (unless otherwise noted)

|                 | PARAMETER                               | TEST CONDITIONS  | MIN | TYP | MAX | UNIT  |
|-----------------|---|--|-----|-----|-----|-------|
|                 | Current flowing into VDD <sup>(3)</sup> | Normal operation, DACs at full scale, ±25µA output range, digital pins static  |     | 42  | 50  |       |
|                 |   | Normal operation, DACs at full scale, ±50µA output range, digital pins static  |     | 56  | 70  | μΑ/ch |
| I <sub>DD</sub> |   | Normal operation, DACs at full scale, ±125μA output range, digital pins static |     | 98  | 120 | μΑ/CΠ |
|                 |   | Normal operation, DACs at full scale, ±250μA output range, digital pins static |     | 167 | 200 |       |

- (1) Measured between end-point codes 0d to 255d.
- (2) Specified by design and characterization, not production tested.
- (3) The current flowing into VDD doesn't account for the load current sourced or sinked on the OUTx pins. The VREF pin is connected to VDD.
- (4) Measured between DAC codes 10d and 255d.



# 6.7 Electrical Characteristics - Comparator Mode

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to +125°C and typical specifications at  $T_A = 25^{\circ}\text{C}$ , 1.8 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, DAC reference tied to VDD, gain = 1x in voltage output mode, DAC output pin (OUT) loaded with resistive load ( $R_L = 5 \text{ k}\Omega$  to AGND) and capacitive load ( $R_L = 200 \text{ pF}$  to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

|                         | PARAMETER                   | TEST CONDITIONS  | MIN        | TYP | MAX                              | UNIT |
|-------------------------|-----------------------------|--|------------|-----|----------------------------------|------|
| STAT                    | TIC PERFORMANCE             |  |            |     | -                                |      |
|                         | Offset error <sup>(1)</sup> | 1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V  | <b>-</b> 5 | TBD | 5                                | mV   |
|                         | Offset error time drift     | Measured at VDD = 5.5 V, external reference, 125°C, FB in Hi-Z mode, DAC at full-scale and VFB at 0 V or DAC at zero-scale and VFB at 1.84 V. Drift specified for 10 years of continuous operation   |            | 4   |                                  | mV   |
| OUT                     | PUT CHARACTERISTICS         |  |            |     | •                                |      |
|                         | Input signal range          | V <sub>REF</sub> connected to V <sub>DD</sub> , V <sub>FB</sub> resistor network connected to ground   | 0          |     | V <sub>DD</sub>                  | V    |
|                         | input signal range          | $V_{REF}$ connected to $V_{DD}$ , $V_{FB}$ resistor network disconnected from ground   | 0          |     | / <sub>DD</sub> (1/3<br>- 1/100) | V    |
| V <sub>OL</sub>         | Logic low output voltage    | I <sub>LOAD</sub> = 100 μA   |            | 0.1 |                                  | V    |
| DYN                     | AMIC PERFORMANCE            |  |            |     |                                  |      |
| t <sub>resp-</sub> comp | Output response time        | Measured with:  DAC at mid-scale, FB input at Hi-Z, and transition step at FB node is (V <sub>DAC</sub> – 2LSB) to (V <sub>DAC</sub> + 2LSB).  Transition time measured between 10% and 90% of output.  Output current of 100 μA.  Comparator output configured in push-pull mode.  Load capacitor at DAC output is 25 pF. |            | 15  |                                  | µs   |

<sup>(1)</sup> Measured at DAC at mid-scale, comparator input at Hi-Z, and DAC operating with external reference.



# 6.8 Electrical Characteristics - General

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to +125°C and typical specifications at  $T_A = 25^{\circ}\text{C}$ , 1.8 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, DAC reference tied to VDD, gain = 1x in voltage output mode or  $\pm 250\mu\text{A}$  output range in current output mode, DAC output pin (OUT) loaded with resistive load ( $R_L = 5 \text{ k}\Omega$  to AGND) in voltage-output mode and capacitive load ( $R_L = 200 \text{ pF}$  to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

|                   | PARAMETER   | TEST CONDITIONS  | MIN | TYP   | MAX      | UNIT   |
|-------------------|---|--|-----|-------|----------|--------|
| INTER             | RNAL REFERENCE  |  |     |       |          |        |
|                   | Initial accuracy  | T <sub>A</sub> = 25°C  |     | 1.212 |          | V      |
|                   | Reference output temperature coefficient <sup>(1)</sup>     |  |     |       | 50       | ppm/°C |
| EXTE              | RNAL REFERENCE  |  |     |       |          |        |
|                   | External reference input range                              |  | 1.7 |       | $V_{DD}$ | V      |
| EEPR              | ROM   |  |     |       |          |        |
|                   | Endurance   | -40°C ≤ T <sub>A</sub> ≤ 85°C  |     | 20000 |          | Cycles |
|                   | Endurance   | 125°C  |     | 1000  |          | Cycles |
|                   | Data retention <sup>(1)</sup>                               | T <sub>A</sub> = 25°C  |     | 50    |          | Years  |
|                   | EEPROM programming write cycle time <sup>(1)</sup>          |  |     |       | 200      | ms     |
| DIGIT             | AL INPUTS   |  |     |       |          |        |
|                   | Digital feedthrough   | Voltage output mode, DAC output static at midscale, fast+ mode, SCL toggling                   |     | 20    |          | nV-s   |
|                   | Pin capacitance   | Per pin  |     | 10    |          | pF     |
| POW               | ER-DOWN MODE  |  |     |       | '        |        |
| I <sub>DD</sub>   | Current flowing into VDD                                    | DAC in sleep mode, internal reference powered down   |     |       | 17       | μA     |
| I <sub>DD</sub>   | Current flowing into VDD                                    | DAC in deep-sleep mode, internal reference powered down  |     |       | 3        | μΑ     |
| HIGH              | -IMPEDANCE OUTPUT   |  |     |       |          |        |
| I <sub>LEAK</sub> | Current flowing into $V_{\text{OUTX}}$ and $V_{\text{FBX}}$ | DAC in Hi-Z output mode, 1.7V ≤ V <sub>DD</sub> ≤ 5.5V   |     | 10    |          | nA     |
| I <sub>LEAK</sub> | Current flowing into $V_{\text{OUTX}}$ and $V_{\text{FBX}}$ | $V_{DD}$ = 0 V, $V_{OUT}$ ≤ 1.5V, Decoupling capacitor between $V_{DD}$ and AGND: 0.1µF        |     | 200   |          | nA     |
| I <sub>LEAK</sub> | Current flowing into $V_{\text{OUTX}}$ and $V_{\text{FBX}}$ | $V_{DD}$ = 0 V, 1.5V < $V_{OUT}$ ≤ 5.5V, Decoupling capacitor between $V_{DD}$ and AGND: 0.1µF |     | 500   |          | nA     |
| I <sub>LEAK</sub> | Current flowing into VOLTY and                              | 100K between $V_{DD}$ and AGND, $V_{OUT} \le$ 1.25V, series resistance of 10KΩ at OUT pin      |     | 2     |          | μA     |

<sup>(1)</sup> Specified by design and characterization, not production tested.



# 6.9 Timing Requirements: I<sup>2</sup>C Standard Mode

all input signals are timed from VIL to 70% of  $V_{DD}$ , 1.8 V  $\leq$   $V_{DD}$   $\leq$  5.5 V,  $-40^{\circ}$ C  $\leq$   $T_{A}$   $\leq$  +125 $^{\circ}$ C, and 1.8 V  $\leq$   $V_{pull-up}$   $\leq$   $V_{DD}$  V

|                    |   | MIN  | NOM MAX | UNIT |
|--------------------|---|------|---------|------|
| f <sub>SCLK</sub>  | SCL frequency                                   |      | 100     | kHz  |
| t <sub>BUF</sub>   | Bus free time between stop and start conditions | 4.7  |         | μs   |
| t <sub>HDSTA</sub> | Hold time after repeated start                  | 4    |         | μs   |
| t <sub>SUSTA</sub> | Repeated start setup time                       | 4.7  |         | μs   |
| t <sub>SUSTO</sub> | Stop condition setup time                       | 4    |         | μs   |
| t <sub>HDDAT</sub> | Data hold time                                  | 0    |         | ns   |
| t <sub>SUDAT</sub> | Data setup time                                 | 250  |         | ns   |
| t <sub>LOW</sub>   | SCL clock low period                            | 4700 |         | ns   |
| t <sub>HIGH</sub>  | SCL clock high period                           | 4000 |         | ns   |
| t <sub>F</sub>     | Clock and data fall time                        |      | 300     | ns   |
| t <sub>R</sub>     | Clock and data rise time                        |      | 1000    | ns   |

# 6.10 Timing Requirements: I<sup>2</sup>C Fast Mode

all input signals are timed from VIL to 70% of  $V_{DD}$ , 1.8 V  $\leq$   $V_{DD}$   $\leq$  5.5 V,  $-40^{\circ}$ C  $\leq$   $T_{A}$   $\leq$  +125 $^{\circ}$ C, and 1.8 V  $\leq$   $V_{pull-up}$   $\leq$   $V_{DD}$  V

| _                  | 55, 55,   | MIN  | NOM MAX | UNIT |
|--------------------|---|------|---------|------|
| f <sub>SCLK</sub>  | SCL frequency                                   |      | 400     | kHz  |
| t <sub>BUF</sub>   | Bus free time between stop and start conditions | 1.3  |         | μs   |
| t <sub>HDSTA</sub> | Hold time after repeated start                  | 0.6  |         | μs   |
| t <sub>SUSTA</sub> | Repeated start setup time                       | 0.6  |         | μs   |
| t <sub>SUSTO</sub> | Stop condition setup time                       | 0.6  |         | μs   |
| t <sub>HDDAT</sub> | Data hold time                                  | 0    |         | ns   |
| t <sub>SUDAT</sub> | Data setup time                                 | 100  |         | ns   |
| t <sub>LOW</sub>   | SCL clock low period                            | 1300 |         | ns   |
| t <sub>HIGH</sub>  | SCL clock high period                           | 600  |         | ns   |
| t <sub>F</sub>     | Clock and data fall time                        |      | 300     | ns   |
| t <sub>R</sub>     | Clock and data rise time                        |      | 300     | ns   |

# 6.11 Timing Requirements: I<sup>2</sup>C Fast Mode Plus

all input signals are timed from VIL to 70% of  $V_{DD}$ , 1.8 V  $\leq$   $V_{DD}$   $\leq$  5.5 V,  $-40^{\circ}$ C  $\leq$   $T_{A}$   $\leq$  +125 $^{\circ}$ C, and 1.8 V  $\leq$   $V_{pull-up}$   $\leq$   $V_{DD}$  V

|                    |   | MIN  | NOM MAX | UNIT |
|--------------------|---|------|---------|------|
| f <sub>SCLK</sub>  | SCL frequency                                   |      | 1       | MHz  |
| t <sub>BUF</sub>   | Bus free time between stop and start conditions | 0.5  |         | μs   |
| t <sub>HDSTA</sub> | Hold time after repeated start                  | 0.26 |         | μs   |
| t <sub>SUSTA</sub> | Repeated start setup time                       | 0.26 |         | μs   |
| t <sub>SUSTO</sub> | Stop condition setup time                       | 0.26 |         | μs   |
| t <sub>HDDAT</sub> | Data hold time                                  | 0    |         | ns   |
| t <sub>SUDAT</sub> | Data setup time                                 | 50   |         | ns   |
| t <sub>LOW</sub>   | SCL clock low period                            | 0.5  |         | μs   |
| t <sub>HIGH</sub>  | SCL clock high period                           | 0.26 |         | μs   |
| t <sub>F</sub>     | Clock and data fall time                        |      | 120     | ns   |
| t <sub>R</sub>     | Clock and data rise time                        |      | 120     | ns   |



# 6.12 Timing Requirements: SPI Write Operation

all input signals are timed from VIL to 70% of  $V_{DD}$ ,  $V_{DD}$  = 1.8 V to 5.5 V, and  $-40^{\circ}C \le T_{A} \le +125^{\circ}C$ 

|                        |  | MIN | NOM | MAX | UNIT |
|------------------------|--|-----|-----|-----|------|
| f <sub>(SCLK)</sub>    | Serial clock frequency, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                                  |     |     | 25  | MHz  |
| t <sub>SCLKHIGH</sub>  | SCLK high time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V  | 18  |     |     | ns   |
| t <sub>SCLKLOW</sub>   | SCLK low time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V   | 18  |     |     | ns   |
| t <sub>SDIS</sub>      | SDI setup time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V  | 8   |     |     | ns   |
| t <sub>SDIH</sub>      | SDI hold time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V   | 8   |     |     | ns   |
| t <sub>CSS</sub>       | CS to SCLK falling edge setup time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                      | 18  |     |     | ns   |
| t <sub>CSH</sub>       | SCLK falling edge to $\overline{\text{CS}}$ rising edge, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V | 10  |     |     | ns   |
| t <sub>CSHIGH</sub>    | <del>CS</del> hight time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                                | 50  |     |     | ns   |
| t <sub>DACWAIT</sub>   | Sequential DAC update wait time for same channel, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V        | 2   |     |     | μs   |
| t <sub>BCASTWAIT</sub> | Broadcast DAC update wait time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                          | 2   |     |     | μs   |

# 6.13 Timing Requirements: SPI Read and Daisy Chain Operation

all input signals are timed from VIL to 70% of  $V_{DD}$ ,  $V_{DD}$  = 1.8 V to 5.5 V, and  $-40^{\circ}C \leq T_{A} \leq +125^{\circ}C$ 

|                       |  | MIN | NOM | MAX | UNIT |
|-----------------------|--|-----|-----|-----|------|
| f <sub>(SCLK)</sub>   | Serial clock frequency, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                      |     |     | 1   | MHz  |
| t <sub>SCLKHIGH</sub> | SCLK high time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                              | 400 |     |     | ns   |
| t <sub>SCLKLOW</sub>  | SCLK low time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                               | 400 |     |     | ns   |
| t <sub>SDIS</sub>     | SDI setup time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V                              | 8   |     |     | ns   |
| t <sub>SDIH</sub>     | SDI hold time, 1.7 V $\leq$ V <sub>DD</sub> $\leq$ 5.5 V                     | 8   |     |     | ns   |
| t <sub>CSS</sub>      | CS to SCLK falling edge setup time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V          | 400 |     |     | ns   |
| t <sub>CSH</sub>      | SCLK falling edge to CS rising edge, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V         | 10  |     |     | ns   |
| t <sub>CSHIGH</sub>   | $\overline{\text{CS}}$ hight time, 1.7 V $\leq$ V <sub>DD</sub> $\leq$ 5.5 V | 1   |     |     | μs   |

# 6.14 Timing Requirements: GPIO

all input signals are timed from VIL to 70% of  $V_{DD}$ ,  $V_{DD}$  = 1.8 V to 5.5 V, and  $-40^{\circ}$ C  $\leq$   $T_{A} \leq$  +125 $^{\circ}$ C

|                       |   | MIN | NOM MAX | UNIT |
|-----------------------|---|-----|---------|------|
| t <sub>GPIHIGH</sub>  | GPI high time, 1.7 V $\leq$ V <sub>DD</sub> $\leq$ 5.5 V <sup>(1)</sup>   | 2   |         | μs   |
| t <sub>GPILOW</sub>   | GPI low time, 1.7 V $\leq$ V <sub>DD</sub> $\leq$ 5.5 V <sup>(1)</sup>  | 2   |         | μs   |
| t <sub>GPAWGD</sub>   | LDAC falling edge to DAC update delay, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V <sup>(2)</sup>                                     |     | 2       | μs   |
| t <sub>CS2LDAC</sub>  | CS rising edge to LDAC falling edge, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V  | 1   |         | μs   |
| t <sub>STP2LDAC</sub> | I <sup>2</sup> C STOP bit rising edge to $\overline{\text{LDAC}}$ falling edge, 1.7 V $\leq$ V <sub>DD</sub> $\leq$ 5.5 V | 1   |         | μs   |
| t <sub>LDACW</sub>    | LDAC low time, 1.7 V ≤ V <sub>DD</sub> ≤ 5.5 V  | 2   |         | μs   |

- (1) The SCL, SDA, A0, and A1 pins can be configured as GPIOs that can be configured to perform different channel-specific or independent operations.
- (2) The GPIOs can be configured as channel-specific or global LDAC function. In a channel-specific LDAC mode, the LDAC pins can be used to trigger DAC code patterns stored in the NVM.



# 6.15 Timing Diagrams

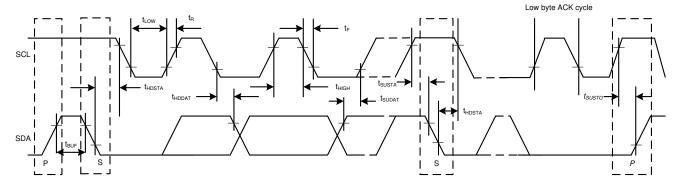


Figure 6-1. I<sup>2</sup>C Timing Diagram

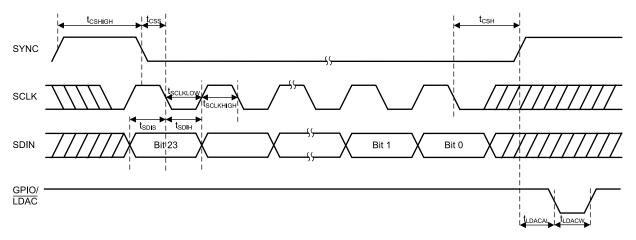


Figure 6-2. SPI Write Timing Diagram

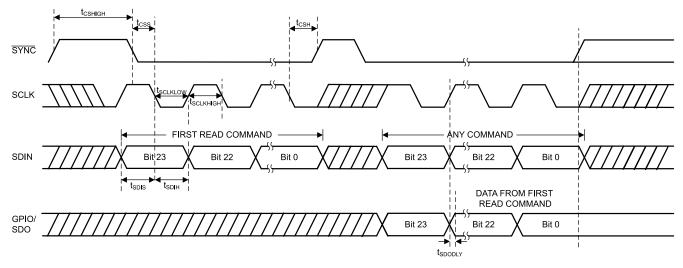


Figure 6-3. SPI Read Timing Diagram



# 7 Detailed Description

### 7.1 Overview

The 12-bit DAC63004 and10-bit DAC53004 (DACx3004) are a pin-compatible family of ultra-low-power, quadchannel, buffered voltage-output and current-output, smart digital-to-analog converters (DACs). The DAC channels are independently configurable as voltage output or current output. The DAC outputs change to Hi-Z when VDD is off; a feature useful in voltage-margining applications. These smart DACs contain nonvolatile memory (NVM), an internal reference, automatically detectable I²C and SPI interface, PMBus-compatibility in I²C mode, force-sense output, and a general-purpose input. These devices support Hi-Z power-down modes by default, which can be configured to 10 k $\Omega$ -GND or 100 k $\Omega$ -GND using the NVM. The DACx3004 have a power-on-reset (POR) circuit that makes sure all the registers start with default or user-programmed settings using NVM. The DACx3004 operate with either an internal reference, external reference, or with power supply as the reference and provide a full-scale output of 1.8 V to 5.5 V.

The DACx3004 devices support I<sup>2</sup>C standard mode (100 kbps), fast mode (400 kbps), and fast mode plus (1 Mbps). The I<sup>2</sup>C interface can be configured with four slave addresses using the A0 pin. These devices also support specific PMBus commands such as *turn on/off*, *margin high or low*, and more. The SPI mode supports a 3-wire interface by default with up to 25-MHz SCLK input. The GPIO input can be configured as SDO in the NVM for SPI read capability. The GPIO input can alternatively be configurable as LDAC, PD, STATUS, FAULT-DUMP, RESET, and PROTECT functions. This device supports a deep-sleep mode in addition to the sleep (power-down) mode. The deep-sleep mode uses the GPIO pin for power-down and wake up, in which the device draws a very low quiescent current of 3 μA. Together with the ultra-low-power operation, the DACx3004 is designed for battery-operated applications like land mobile radio, medical pulse oximeter, and notebook PCs.

The DACx3004 also include digital slew rate control, and support standard waveform generation such as *sine and cosine, triangular*, and *sawtooth* waveforms. These devices can generate pulse-width modulation (PWM) output with the combination of the triangular or sawtooth waveform and the FB pin. The force-sense outputs of the DAC channels can be used as programmable comparators. The comparator mode allows programmable hysteresis, latching comparator, window comparator, and fault-dump to the NVM. These features enable the DACx3004 to go beyond the limitations of a conventional DAC that depends on a processor to function. As a result of processor-less operation and the *smart* feature set, the DACx3004 are called smart DACs.

### 7.2 Functional Block Diagram

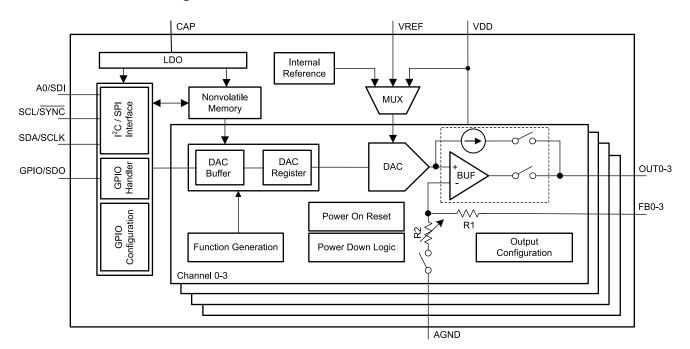


Figure 7-1. Functional Block Diagram



# 7.3 Feature Description

### 7.3.1 Smart Digital-to-Analog Converter (DAC) Architecture

The DACx3004 devices consist of string architecture with a voltage-output amplifier and an external FB pin and voltage-to-current converter for each channel. Section 7.2 shows the DAC architecture within the block diagram, which operates from a 1.8-V to 5.5-V power supply. The DAC has an internal voltage reference of 1.21 V. There is an option to select an external reference on the VREF pin or the power supply as a reference. The voltage output mode uses one of these three reference options. The current output mode uses an internal band gap to generate the current outputs. Both the voltage- and current-output modes support multiple programmable output ranges.

The DACx3004 devices support Hi-Z output when VDD is off, maintaining very low leakage current at the output pins with up to 1.25 V of forced voltage. The DAC output pin also starts up in high-impedance mode by default, making these devices an excellent choice for voltage margining and scaling applications. To change the power-up mode to 10 k $\Omega$ -GND or 100 k $\Omega$ -GND, program the corresponding VOUT-PDN-X field in the COMMON-CONFIG register and load these bits in the device NVM.

The DACx3004 devices support an independent comparator mode for each channel. The respective FBx pins act as the inputs for the comparator. The DAC architecture supports inversion of the comparator output using register settings. The comparator outputs can be push-pull or open-drain. The comparator mode supports programmable hysteresis using *margin-high* and *margin-low* register fields, latching comparator, and window comparator. The comparator outputs are accessible internally by the device.

The DACx3004 devices include a *smart* feature set to enable processor-less operation and high-integration. The NVM enables a predictable start-up. The GPIO triggers the DAC output without the I<sup>2</sup>C interface in the absence of a processor or when the processor or software fails. The integrated functions and the FBx pin enable PWM output for control applications. The FBx pin enables this device to be used as a programmable comparator. The digital slew-rate control and the Hi-Z power-down modes enable a hassle-free voltage margining and scaling function.

#### 7.3.2 Digital Input/Output

The DACx3004 have four digital IO pins that include I<sup>2</sup>C, SPI, PMBus, and GPIO interfaces. These devices automatically detect I<sup>2</sup>C and SPI protocols at the first successful communication after power-on, and then connect to the detected interface. After an interface protocol is connected, any change in the protocol is ignored. The I<sup>2</sup>C interface uses the A0 pin to select from among four address options. The SPI interface is a 3-wire interface by default. No readback capability is available in this mode. The GPIO pin can be configured in the register map and then programmed in to the NVM as the SDO pin. The SPI readback mode is slower than the write mode. The programming interface pins are:

- I<sup>2</sup>C: SCL, SDA, A0
- SPI: SCLK, SDI, SYNC, SDO/GPIO

The GPIO can be configured as multiple functions other than SDO. These are  $\overline{\text{LDAC}}$ ,  $\overline{\text{PD}}$ ,  $\overline{\text{STATUS}}$ ,  $\overline{\text{PROTECT}}$ ,  $\overline{\text{FAULT-DUMP}}$ , and  $\overline{\text{RESET}}$ . All the digital pins are open-drain when used as outputs. Therefore, all the output pins must be pulled up to the desired IO voltage using external registers.



### 7.3.3 Nonvolatile Memory (NVM)

The DACx3004 contain nonvolatile memory (NVM) bits. These memory bits are user programmable and erasable, and retain the set values in the absence of a power supply. All the register bits, as shown in the highlighted gray cells in Table 7-15, can be stored in the NVM by setting NVM-PROG = 1 in the COMMON-TRIGGER register. This is an autoresetting bit. The NVM-BUSY bit in the GENERAL-STATUS register is set to 1 by the device when an NVM write or reload operation is ongoing. During this time, the device blocks all read/write operations to the device. The NVM-BUSY bit is set to 0 after the write or reload operation is complete; at this point, all read/write operations to the device are allowed. The default value for all the registers in the DACx3004 is loaded from NVM as soon as a POR event is issued.

The DACx3004 also implement NVM-RELOAD bit in the COMMON-TRIGGER register. Set this bit to 1 for the device to start an NVM-reload operation. After completion, the device autoresets this bit to 0. During the NVM-RELOAD operation, the NVM-BUSY bit is set to 1.

## 7.3.4 Power Consumption

The power consumption of the DACx3004 in sleep mode is 17  $\mu$ A and in deep-sleep mode 3  $\mu$ A. In normal operation, the total power consumption of the device depends on the number of channels powered on and the output mode of each channel (voltage or current). In current-output mode, the quiescent current depends on the output range as well. The quiescent current calculation excludes the load current. For example, in the  $\pm 250~\mu$ A output mode with a DAC setting of  $\pm 125~\mu$ A, the total current drawn through the VDD pin is the total quiescent current plus 125  $\mu$ A. The total quiescent current in normal operation can be calculated using Equation 1.

$$P_{NORMAL\_MODE} = (V_{DD} \times I_{DD\_SLEEP}) + \sum_{x=0}^{3} (V_{DD} \times I_{DD\_X})$$
(1)

- IDD SLEEP is the quiescent current in sleep mode (when all the channels are powered down).
- $I_{DD} x$  is the quiescent current for channel-X for every channel that is powered on.



#### 7.4 Device Functional Modes

### 7.4.1 Voltage-Output Mode

The voltage-output mode for each DAC channel can be entered by selecting the power-up option in the VOUT-PDN-X fields in the COMMON-CONFIG register and simultaneously powering-down the current output option for the respective channels using the IOUT-PDN-X bits in the same register. Short the OUTx and FBx pins of respective channels externally for closed-loop amplifier output. An open FBx pin saturates the amplifier output. To achive the desired voltage output, select the right reference option, select the amplifier gain for the required output range, and program the DAC code in the DAC-X-DATA register of the respective channels.

### 7.4.1.1 Voltage Reference and DAC Transfer Function

There are three voltage reference options possible with the DACx3004 devices: internal reference, external reference, and the power supply as reference, as shown in Figure 7-2. The DAC transfer function in the voltage-output and comparator modes changes based on the voltage reference selection.

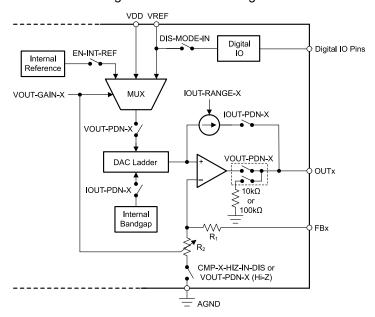


Figure 7-2. Voltage Reference Selection and Power-Down Logic

#### 7.4.1.1.1 Internal Reference

The DACx3004 contain an internal reference that is disabled by default. To enable the internal reference, write 1 to bit EN-INT-REF in the COMMON-CONFIG register. The internal reference generates a fixed 1.21-V voltage (typical). Use the VOUT-GAIN-X field in the DAC-X-VOUT-CMP-CONFIG register to achieve gains of 1.5x, 2x, 3x, or 4x for the DAC output voltage ( $V_{OUT}$ ). Equation 2 shows DAC transfer function using the internal reference.

$$V_{OUT} = \frac{DAC\_DATA}{2^{N}} \times V_{REF} \times GAIN$$
(2)

- N is the resolution in bits, 10 (DAC53004), or 12 (DAC63004).
- DAC\_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA field in the DAC-X-DATA register.
- DAC\_DATA ranges from 0 to 2<sup>N</sup> 1.
- V<sub>RFF</sub> is the internal reference voltage = 1.21 V.
- GAIN = 1.5x, 2x, 3x, or 4x, based on VOUT-X-GAIN bits.



#### 7.4.1.1.2 External Reference

The DACx3004 provide an external reference input. Select the external reference option by configuring the VOUT-GAIN-X field in the DAC-X-VOUT-CMP-CONFIG register appropriately. Write 1 to the DIS-MODE-IN bit in the DEVICE-MODE-CONFIG register to minimize quiescent current. The external reference can be between 1.8 V and VDD. Equation 3 shows DAC transfer function when the external reference is used.

#### Note

The external reference must be less than VDD in both transient and steady-state conditions. Therefore, the external reference must ramp up after VDD and ramp down before VDD.

$$V_{OUT} = \frac{DAC\_DATA}{2^N} \times V_{REF}$$
(3)

#### where:

- N is the resolution in bits, 10 (DAC53004), or 12 (DAC63004).
- DAC\_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA field in the DAC-X-DATA register.
- DAC\_DATA ranges from 0 to 2<sup>N</sup> 1.
- V<sub>REF</sub> is the external reference voltage.

### 7.4.1.1.3 Power-Supply as Reference

By default, the DACx3004 operate with the power-supply pin (VDD) as a reference. Equation 4 shows DAC transfer function when the power-supply pin is used as reference. The gain at the output stage is always 1x.

$$V_{OUT} = \frac{DAC\_DATA}{2^{N}} \times V_{DD}$$
 (4)

- N is the resolution in bits, either 10 (DAC53004), or 12 (DAC63004).
- DAC\_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA field in the DAC-X-DATA register.
- DAC DATA ranges from 0 to 2<sup>N</sup> 1.
- V<sub>DD</sub> is used as the DAC reference voltage.



### 7.4.2 Current-Output Mode

The current-output mode for each DAC channel can be entered by disabling respective IOUT-PDN-X bits in the COMMON-CONFIG register and putting the respective VOUT-PDN-X fields in the same register in Hi-Z power-down. Select the desired current-output range by writing to the IOUT-RANGE-X field in the DAC-X-IOUT-MISC-CONFIG register. To minimize leakage in current-output mode, disconnect the FBx pin. The internal trimming settings for voltage-output and current-output modes are different; therefore, there can be a momentary dc offset when switching between voltage-output to current-output modes. Program the mode selection into the NVM to avoid this offset. The transfer function of the current-output is shown in Equation 5.

$$I_{OUT} = \frac{DAC\_DATA \times (I_{MAX} - I_{MIN})}{2^8} + I_{MIN}$$
(5)

where:

- DAC\_DATA is the DAC-X-DATA code as specified in Section 7.6.8.
- I<sub>MAX</sub> is the signed maximum current in the IOUT-RANGE-X setting as specified in Section 7.6.5.
- I<sub>MIN</sub> is the signed minimum current in the IOUT-RANGE-X setting as specified in Section 7.6.5.

### 7.4.3 Comparator Mode

All the DAC channels can be configured as programmable comparators. To enter the comparator mode for a channel, write 1 to the CMP-X-EN and the CMP-X-OUT-EN bits in the respective DAC-X-VOUT-CMP-CONFIG register. The comparator output can be configured as push-pull or open-drain using the CMP-X-OD-EN bit. To invert the comparator output, write 1 to the CMP-X-INV-EN bit. The FBx pin has a finite impedance. To enable high-impedance on the FBx pin, write 1 to the CMP-X-HIZ-IN-DIS bit.

#### Note

In the Hi-Z input mode, the comparator input range is limited to:

- For GAIN = 1x, 1.5x, or 2x:  $V_{FB} \le (V_{REF} \times GAIN) / 3$
- For GAIN = 3x, or 4x: V<sub>FB</sub> ≤ (V<sub>REF</sub> × GAIN) / 6

Any higher input voltage is clipped.

Individual comparator channels can be configured in no-hysteresis, with-hysteresis, and window-comparator modes using the CMP-X-MODE field in the respective DAC-X-CMP-MODE-CONFIG register.

#### 7.4.4 Application-Specific Modes

This section provides the details of application-specific functional modes available in DACx3004.

#### 7.4.4.1 Voltage Margining and Scaling

Voltage margining or scaling is a primary application for DACx3004. This section provides specific features available for this application such as Hi-Z output, slew-rate control, PROTECT input, and PMBus compatibility.

#### 7.4.4.1.1 High-Impedance Output and PROTECT Input

All the DAC output channels remain in high-impedance (Hi-Z) when VDD is off. Figure 7-3 shows a simplified schematic of DACx3004 used in a voltage-margining application. The series resistor  $R_S$  is needed in voltage-output mode, but is optional in current-output mode. Almost all linear regulators and DC/DC converters have a feedback voltage of  $\leq$  1.25 V. The low-leakage currents at the outputs are maintained for  $V_{FB}$  of  $\leq$  1.25 V. Thus, for all practical purposes, the DAC outputs appear as Hi-Z when VDD of the DAC is off in voltage margining and scaling applications. This feature allows for seamless integration of the DACx3004 into a system without any need for additional power-supply sequencing for the DAC.

The DAC channels power down to Hi-Z at boot up. The outputs can power up with a preprogrammed code that corresponds to the nominal output of the DC/DC converter or the linear regulator. This feature allows for smooth power up and power down of the DAC without impacting the feedback loop of the DC/DC converter or the linear regulator.

**ADVANCE INFORMATION** 

The GPIO pin of the DACx3004 can be configured as a PROTECT function. PROTECT takes the DAC outputs to a predictable state with a slewed or direct transition. This function is useful in systems where a fault condition (such as a brownout), a subsystem failure, or a software crash requires that the DAC outputs reach a predefined state without the involvement of a processor. The detected event can be fed to the GPIO pin configured as the PROTECT input. The PROTECT function is triggered using the PROTECT bit in the COMMON-TRIGGER register. Configure the behavior of the PROTECT function in the PROTECT-CONFIG field in the DEVICE-MODE-CONFIG register.

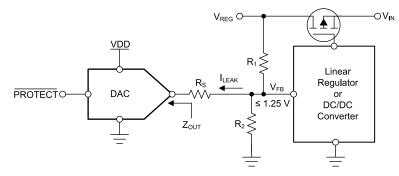


Figure 7-3. High-Impedance (Hi-Z) Output and PROTECT Input

#### 7.4.4.1.2 Programmable Slew-Rate Control

When the DAC data registers are written, the voltage on DAC output  $(V_{OUT})$  immediately transitions to the new code following the slew rate and settling time specified in the *Electrical Characteristics*. The slew rate control feature allows the user to control the rate at which the output voltage  $(V_{OUT})$  changes. When this feature is enabled (using SLEW-RATE-X[3:0] bits), the DAC output changes from the current code to the code in DAC-X-MARGIN-HIGH or DAC-X-MARGIN-LOW registers (when margin high or low commands are issued to the DAC) using the step and rate set in CODE-STEP-X and SLEW-RATE-X bits in the DAC-X-FUNC-CONFIG register. With the default slew rate control setting of no-slew, the output changes smoothly at a rate limited by the output drive circuitry and the attached load. Using the slew-rate control feature, the output steps digitally at a rate defined by bits CODE-STEP-X and SLEW-RATE-X. SLEW-RATE-X defines the rate at which the digital slew updates; CODE-STEP-X defines the amount by which the output value changes at each update, for the corresponding channels. Table 7-1 and Table 7-2 show different settings available for CODE-STEP-X and SLEW-RATE-X.

When the slew rate control feature is used, the output changes happen at the programmed slew rate. This configuration results in a staircase formation at the output as shown in Figure 7-4. Do not write to CODE-STEP-X, SLEW-RATE-X, or DAC-X-DATA during the output slew operation.

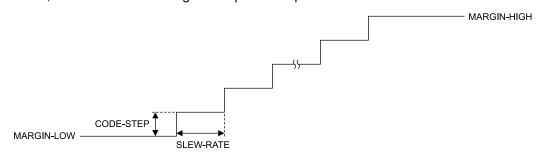


Figure 7-4. Programmable Slew-Rate Control



Table 7-1. Code Step

|                   |                | raise i ii e e a e e e e e |                |                 |
|-------------------|----------------|----------------------------|----------------|-----------------|
| REGISTER          | CODE-STEP-X[2] | CODE-STEP-X[1]             | CODE-STEP-X[0] | CODE STEP SIZE  |
|                   | 0              | 0                          | 0              | 1 LSB (default) |
|                   | 0              | 0                          | 1              | 2 LSB           |
|                   | 0              | 1                          | 0              | 3 LSB           |
| DAC-X-FUNC-CONFIG | 0              | 1                          | 1              | 4 LSB           |
| DAC-X-FUNC-CONFIG | 1              | 0                          | 0              | 6 LSB           |
|                   | 1              | 0                          | 1              | 8 LSB           |
|                   | 1              | 1                          | 0              | 16 LSB          |
|                   | 1              | 1                          | 1              | 32 LSB          |

### Table 7-2. Slew Rate

|                    |                | 145.0 / 2.     | DIEW ITALE     |                |                           |       |   |   |   |   |   |   |   |          |
|--------------------|----------------|----------------|----------------|----------------|---------------------------|-------|---|---|---|---|---|---|---|----------|
| REGISTER           | SLEW-RATE-X[3] | SLEW-RATE-X[2] | SLEW-RATE-X[1] | SLEW-RATE-X[0] | TIME PERIOD<br>(PER STEP) |       |   |   |   |   |   |   |   |          |
|                    | 0              | 0              | 0              | 0              | No slew (default)         |       |   |   |   |   |   |   |   |          |
|                    | 0              | 0              | 0              | 1              | 4 μs                      |       |   |   |   |   |   |   |   |          |
|                    | 0              | 0              | 1              | 0              | 8 µs                      |       |   |   |   |   |   |   |   |          |
|                    | 0              | 0              | 0              | 1              | 1                         | 12 µs |   |   |   |   |   |   |   |          |
|                    | 0              | 1              | 0              | 0              | 18 µs                     |       |   |   |   |   |   |   |   |          |
|                    | 0              | 1              | 0              | 1              | 27 µs                     |       |   |   |   |   |   |   |   |          |
|                    | 0              | 1              | 1              | 0              | 40.5 μs                   |       |   |   |   |   |   |   |   |          |
| DAC-X-FUNC-CONFIG  | 0              | 1              | 1              | 1              | 60.75 μs                  |       |   |   |   |   |   |   |   |          |
| DAG-X-I ONG-CON IG | 1              | 0              | 0              | 0              | 91.13 µs                  |       |   |   |   |   |   |   |   |          |
|                    | 1              | 0              | 0              | 1              | 136.69 µs                 |       |   |   |   |   |   |   |   |          |
|                    | 1              | 1              | 1              | 1              | 1                         | 1     | 1 | 1 | 1 | 1 | 0 | 1 | 0 | 239.2 µs |
|                    | 1              | 0              | 1              | 1              | 418.61 µs                 |       |   |   |   |   |   |   |   |          |
|                    | 1              | 1              | 0              | 0              | 732.56 µs                 |       |   |   |   |   |   |   |   |          |
|                    | 1              | 1              | 0              | 1              | 1281.98 µs                |       |   |   |   |   |   |   |   |          |
|                    | 1              | 1 1 1 0        |                | 0              | 1281.98 µs                |       |   |   |   |   |   |   |   |          |
|                    | 1              | 1              | 1              | 1              | 5127.92 µs                |       |   |   |   |   |   |   |   |          |



#### 7.4.4.1.3 PMBus Compatibility Mode

The PMBus protocol is an I<sup>2</sup>C-based communication standard for power-supply management. PMBus contains standard command codes tailored to power supply applications. The DACx3004 implement some PMBus commands such as *Turn Off, Turn On, Margin Low, Margin High, Communication Failure Alert Bit (CML)*, as well as *PMBUS revision*. Figure 7-5 shows typical PMBus connections. The EN-PMBUS bit in the INTERFACE-CONFIG register must be set to 1 to enable the PMBus protocol.

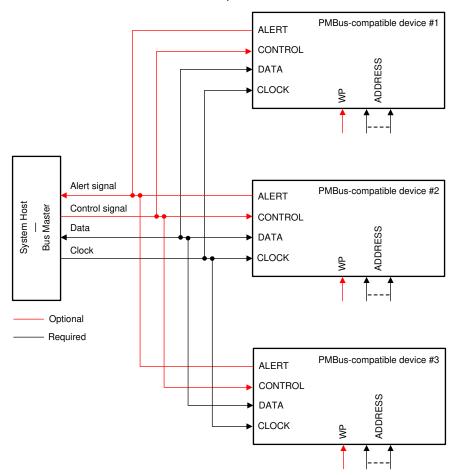


Figure 7-5. PMBus Connections



Similar to I<sup>2</sup>C, PMBus is a variable length packet of 8-bit data bytes, each with a receiver acknowledge, wrapped between a start and stop bit. The first byte is always a 7-bit slave address followed by a write bit, sometimes called the even address that identifies the intended receiver of the packet. The second byte is an 8-bit command byte, identifying the PMBus command being transmitted using the respective command code. After the command byte, the transmitter either sends data associated with the command to write to the receiver command register (from least significant byte to most significant byte, as shown in Table 7-3), or sends a new start bit indicating the desire to read the data associated with the command register from the receiver. Then the receiver transmits the data following the same least significant byte first format (see Table 7-4).

Table 7-3. PMBus Update Sequence

| MSB        |                        | LSB | ACK       | MSB |                       | LSB | ACK            | MSB  |          | LSB | ACK      | MSB                            |  | LSB | ACK |
|------------|------------------------|-----|-----------|-----|-----------------------|-----|----------------|------|----------|-----|----------|--------------------------------|--|-----|-----|
|            | ress (A)<br>tion 7.5.2 | ,   |           |     | mmand b<br>tion 7.5.2 | •   |                | Data | byte - L | SDB |          | Data byte - MSDB<br>(Optional) |  |     |     |
| DB [31:24] |                        |     | DB [23:16 | 6]  |                       | I   | DB [15:8] DB [ |      |          |     | DB [7:0] |                                |  |     |     |

Table 7-4. PMBus Read Sequence

| s                              | MSB    |      | R/ W<br>(0) | ACK   | MSB                            |      | LSB   | ACK   | Sr | MSB                            |         | R/ W<br>(1) | ACK   | мѕв  |      | LSB | ACK    | MSB           |     | LSB  | ACK    |
|--------------------------------|--------|------|-------------|-------|--------------------------------|------|-------|-------|----|--------------------------------|---------|-------------|-------|------|------|-----|--------|---------------|-----|------|--------|
| ADDRESS BYTE Section 7.5.2.2.1 |        | n    |             | S     | MMA<br>BYTE<br>ection<br>5.2.2 | on   |       | Sr    | S  | DRE<br>BYTI<br>ection<br>5.2.2 | E<br>on |             | L     | .SDE | 3    |     | l      | /ISD<br>otior |     |      |        |
| ·                              | From N | Иast | er          | Slave | Fron                           | n Ma | aster | Slave |    | From I                         | Mas     | ter         | Slave | Froi | n SI | ave | Master | Fro           | m S | lave | Master |

The DACx3004 I<sup>2</sup>C interface implements some of the PMBus commands. Table 7-5 shows the supported PMBus commands that are implemented in DACx3004. The DAC uses DAC-X-MARGIN-LOW, DAC-X-MARGIN-HIGH bits, SLEW-RATE-X, and CODE-STEP-X bits for PMBUS-OPERATION-CMD-X. To access multiple channels, write to the PMBUS-PAGE register first followed by a write to the channel-specific register.

**Table 7-5. PMBus Operation Commands** 

| REGISTER           | PMBUS-OPERATION-CMD-X[15:8] | DESCRIPTION |  |  |  |
|--------------------|-----------------------------|-------------|--|--|--|
|                    | 00h                         | Turn off    |  |  |  |
| PMBUS-OP-CMD-X     | 80h                         | Turn on     |  |  |  |
| FINIDUS-OF-CIVID-X | 94h                         | Margin low  |  |  |  |
|                    | A4h                         | Margin high |  |  |  |

The DACx3004 also implement PMBus features such as group command protocol and communication time-out failure. The CML bit in the PMBUS-CML register indicates a communication fault in the PMBus. This bit is reset by writing 1.

To get the PMBus version, read the PMBUS-VERSION register.



#### 7.4.4.2 Function Generation

The DACx3004 implement a continuous function or waveform generation feature. These devices can generate a triangular wave, sawtooth wave, and sine wave independently for every channel.

## 7.4.4.2.1 Triangular Waveform Generation

The triangular waveform uses the DAC-X-MARGIN-LOW and DAC-X-MARGIN-HIGH registers for minimum and maximum levels, respectively. The frequency of the waveform depends on the min and max levels, CODE-STEP and SLEW-RATE settings as shown in Equation 6. An external RC load with a time-constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The CODE-STEP-X and SLEW-RATE-X settings are available in the DAC-X-FUNC-CONFIG register. Writing 0b000 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register selects triangular waveform.

$$f_{TRIANGLE-WAVE} = \frac{1}{2 \times SLEW\_RATE \times \left(\frac{MARGIN\_HIGH-MARGIN\_LOW+1}{CODE\_STEP}\right)}$$
(6)

#### where:

- SLEW\_RATE is the SLEW-RATE-X setting as specified in Table 7-2.
- CODE STEP is the CODE-STEP-X setting as specified in Table 7-1.
- MARGIN HIGH is the DAC-X-MAGIN-HIGH as specified in Section 7.6.2.
- MARGIN\_LOW is the DAC-X-MAGIN-LOW as specified in Section 7.6.3.

#### 7.4.4.2.2 Sawtooth Waveform Generation

The sawtooth and the inverse sawtooth waveforms use the DAC-X-MARGIN-LOW and DAC-X-MARGIN-HIGH registers for minimum and maximum levels, respectively. The frequency of the waveform depends on the min and max levels, CODE-STEP and SLEW-RATE settings as shown in Equation 7. An external RC load with a time constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The CODE-STEP-X and SLEW-RATE-X settings are available in the DAC-X-FUNC-CONFIG register. Write 0b001 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register to select sawtooth waveform, and write 0b010 to select inverse sawtooth waveform.

$$f_{SAWTOOTH-WAVE} = \frac{1}{SLEW\_RATE \times \left(\frac{MARGIN\_HIGH-MARGIN\_LOW+1}{CODE\_STEP}\right)}$$
(7)

- SLEW\_RATE is the SLEW-RATE-X setting as specified in Table 7-2.
- CODE STEP is the CODE-STEP-X setting as specified in Table 7-1.
- MARGIN HIGH is the DAC-X-MAGIN-HIGH as specified in Section 7.6.2.
- MARGIN LOW is the DAC-X-MAGIN-LOW as specified in Section 7.6.3.



#### 7.4.4.2.3 Sine Waveform Generation

The sine wave function uses 24 preprogrammed points per cycle. The frequency of the sine wave depends on the SLEW-RATE settings as shown in Equation 8. An external RC load with a time constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The SLEW-RATE-X setting is available in the DAC-X-FUNC-CONFIG register. Writing 0b100 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register selects sine wave. The minimum level for the sine wave is always zero-code and the maximum level is always full-code. Use the gain settings at the output amplifier for changing the full-scale output using the internal reference option. The gain settings are accessible through the VOUT-GAIN-X bits in the DAC-X-VOUT-CMP-CONFIG register. There are four phase settings available for the sine wave that are selected using the PHASE-SEL-X bit in the DAC-X-FUNC-CONFIG register.

$$f_{SINE} = \frac{1}{24 \times SLEW\_RATE}$$
 (8)

where:

SLEW\_RATE is the SLEW-RATE-X setting as specified in Table 7-2.

## 7.4.5 Device Reset and Fault Management

This section provides the details of power-on-reset (POR), software reset, and other diagnostics and fault-management features of DACx3004.

# 7.4.5.1 Power-on-Reset (POR)

The DACx3004 family of devices includes a power-on reset (POR) function that controls the output voltage at power up. After the  $V_{DD}$  supply has been established, a POR event is issued. The POR causes all registers to initialize to default values, and communication with the device is valid only after a POR (boot-up) delay. The default value for all the registers in the DACx3004 is loaded from NVM as soon as the POR event is issued.

When the device powers up, a POR circuit sets the device to the default mode. The POR circuit requires specific  $V_{DD}$  levels, as indicated in Figure 7-6, in order to make sure that the internal capacitors discharge and reset the device on power up. To make sure that a POR occurs,  $V_{DD}$  must be less than 0.7 V for at least 1 ms. When  $V_{DD}$  drops to less than 1.65 V, but remains greater than 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power-supply conditions. In this case, initiate a POR. When  $V_{DD}$  remains greater than 1.65 V, a POR does not occur.

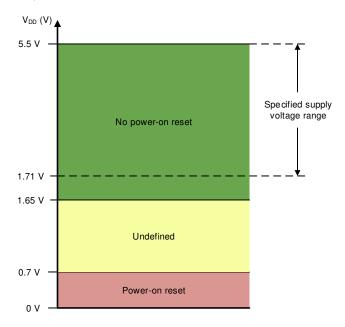


Figure 7-6. Threshold Levels for V<sub>DD</sub> POR Circuit



#### 7.4.5.2 External Reset

An external reset to the device can be triggered through the GPIO pin or through the register map. To initiate a device software reset event, write the reserved code 1010 to the RESET field in the COMMON-TRIGGER register. A software reset initiates a POR event. The GPIO pin can be configured as a RESET pin as shown in Table 7-13. This configuration must be programmed into the NVM so that the setting is not cleared after the device reset. The RESET input must be a low pulse. The device comes out of reset on the rising edge of the RESET input.

#### 7.4.5.3 Register-Map Lock

The DACx3004 implement a register-map lock feature that prevents an accidental or unintended write to the DAC registers. The device locks all the registers when the DEV-LOCK bit in the COMMON-CONFIG register is set to 1. To bypass the DEV-LOCK setting, write 0101 to the DEV-UNLOCK bits in the COMMON-TRIGGER register.

# 7.4.5.4 NVM Cyclic Redundancy Check (CRC)

The DACx3004 implement a cyclic redundancy check (CRC) feature for the NVM to make sure that the data stored in the NVM is uncorrupted. There are two types of CRC alarm bits implemented in DACx3004:

- NVM-CRC-FAIL-USER
- NVM-CRC-FAIL-INT

The NVM-CRC-FAIL-USER bit indicates the status of user-programmable NVM bits, and the NVM-CRC-FAIL-INT bit indicates the status of internal NVM bits The CRC feature is implemented by storing a 16-Bit CRC (CRC-16-CCITT) along with the NVM data each time NVM program operation (write or reload) is performed and during the device start up. The device reads the NVM data and validates the data with the stored CRC. The CRC alarm bits (NVM-CRC-FAIL-USER and NVM-CRC-FAIL-INT in the GENERAL-STATUS register) report any errors after the data are read from the device NVM. The alarm bits are set only at boot-up.

#### 7.4.5.4.1 NVM-CRC-FAIL-USER Bit

A logic 1 on NVM-CRC-FAIL-USER bit indicates that the user-programmable NVM data are corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see Section 7.4.5.2) command, or cycle power to the DAC. A software reset or power-cycle also reloads the user-programmable NVM bits. In case the failure persists, reprogram the NVM.

#### 7.4.5.4.2 NVM-CRC-FAIL-INT Bit

A logic 1 on NVM-CRC-FAIL-INT bit indicates that the internal NVM data are corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. In case of a temporary failure, to reset the alarm bits to 0, issue a software reset (see *Section 7.4.5.2*) command or cycle power to the DAC. A permanent failure in the NVM makes the device unusable.

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#### 7.4.6 Power-Down Mode

The DACx3004 output amplifier and internal reference can be independently powered down through the EN-INT-REF, VOUT-PDN-X, and IOUT-PDN-X bits in the COMMON-CONFIG register, as shown in Figure 7-2. At power up, the DAC output and the internal reference are disabled by default. In power-down mode, the DAC outputs (OUTx pins) are in a high-impedance state. To change this state to 10 k $\Omega$ -A $_{GND}$  or 100 k $\Omega$ -A $_{GND}$  in the voltage-output mode (at power up), use the VOUT-PDN-X bits. The power-down state for current-output mode is always high-impedance.

The DAC power-up state can be programmed to any state (power-down or normal mode) using the NVM. Table 7-6 shows the DAC power-down bits. The individual channel power-down bits can be mapped to the GPIO pin using the GPIO-CONFIG register. This function is called the sleep mode. In this mode, the internal low-dropout regulator (LDO) and the common functional blocks are still powered-on, and the device draws a maximum of 17 µA of current through the power supply.

VOUT-PDN-X[0] **IOUT-PDN-X REGISTER** VOUT-PDN-X[1] **DESCRIPTION** Power up VOUT-X Power down VOUT-X with 10 k $\Omega$  to AGND. Power down IOUT-X to Hi-Z Power down VOUT-X with 100 k $\Omega$  to AGND. 1 0 **COMMON-CONFIG** Power down IOUT-X to Hi-Z Power down VOUT-X to Hi-Z. 1 1 1 Power down IOUT-X to Hi-Z (default) Power down VOUT-X to Hi-Z. 0 Power up IOUT-X

Table 7-6. DAC Power-Down Bits

# 7.4.6.1 Deep-Sleep Mode

The DACx3004 provides a deep-sleep mode, where the internal LDO and most of the common functional blocks are powered-down. The GPIO pin must be used to enter and exit this mode. The I<sup>2</sup>C or SPI interface does not work during the deep-sleep mode. The steps to enter and exit the deep-sleep mode are:

- 1. Make sure that the GPIO pin is pulled high.
- 2. Write 1 to the DEEP-SLEEP-EN bit in the GPIO-CONFIG register.
- 3. Disable GP output and SDO by writing 0 to GPO1-EN and SDO-EN bits.
- 4. Enable 1 to GPI1-EN and 0b0000 to GPI1-CONFIG bits.
- 5. To program these settings into the NVM, write 1 to the NVM-PROG bit in the COMMON-TRIGGER register.
- A negative-edge trigger on the GPIO puts the device into the deep-sleep mode. The LDO takes approximately 550 µs to switch off. The device remains in this mode as long as the signal is low.
- 7. To bring the device out of the deep-sleep mode, pull the GPIO pin high. The digital circuitry and the LDO takes approximately 550 µs to switch on.



## 7.5 Programming

The DACx3004 are programmed through either a 3-wire SPI or 2-wire I<sup>2</sup>C interface. A 4-wire SPI mode is enabled by mapping the GPIO pin as SDO. The SPI readback operates at a lower SCLK than the standard SPI write operation. The type of interface is determined based on the first protocol to communicate after device power up. After the interface type is determined, the device ignores any change in the type while the device is on. The interface type can be changed after a power cycle.

### 7.5.1 SPI Programming Mode

An SPI access cycle for DACx3004 is initiated by asserting the \$\overline{SYNC}\$ pin low. The serial clock, SCLK, can be a continuous or gated clock. SDI data are clocked on SCLK falling edges. The SPI frame for DACx3004 is 24 bits long. Therefore, the \$\overline{SYNC}\$ pin must stay low for at least 24 SCLK falling edges. The access cycle ends when the \$\overline{SYNC}\$ pin is deasserted high. If the access cycle contains less than the minimum clock edges, the communication is ignored. If the access cycle contains more than the minimum clock edges, only the first 24 bits are used by the device. When \$\overline{SYNC}\$ is high, the SCLK and SDI signals are blocked, and SDO extends the last bit transmitted.

#### Note

The SDO pin does not become Hi-Z when  $\overline{\text{SYNC}}$  is high. Therefore, when sharing a single SPI bus across multiple receivers, disable the SDO pin of the DAC before reading from other receivers.

Table 7-7 describes the format for the 24-bit SPI access cycle. The first byte input to SDI is the instruction cycle. The instruction cycle identifies the request as a read or write command and the 7-bit address that is to be accessed. The last 16 bits in the cycle form the data cycle.

Table 7-7. SPI Write/Read Access Cycle

| BIT     | FIELD    | DESCRIPTION  |
|---------|----------|--|
| 23      | R/W      | Identifies the communication as a read or write command to the address register: $R/W = 0$ sets a write operation. $R/W = 1$ sets a read operation                                       |
| 22 - 16 | • •      | Register address: specifies the register to be accessed during the read or write operation   |
| 15 - 0  | DI[15:0] | Data cycle bits: If a write command, the data cycle bits are the values to be written to the register with address A[6:0]. If a read command, the data cycle bits are don't care values. |

Read operations require that the SDO pin is first enabled by setting the SDO-EN bit in the INTERFACE-CONFIG register. A read operation is initiated by issuing a read command access cycle. After the read command, a second access cycle must be issued to get the requested data. The output data format is shown in Table 7-8. Data are clocked out on the SDO pin either on the falling edge or rising edge of SCLK according to the FSDO bit.

Table 7-8. SDO Output Access Cycle

| BIT     | FIELD    | DESCRIPTION                                      |
|---------|----------|--|
| 23      | R/W      | Echo R/W from previous access cycle              |
| 22 - 16 | A[6:0]   | Echo register address from previous access cycle |
| 15 - 0  | DI[15:0] | Readback data requested on previous access cycle |

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# 7.5.2 I<sup>2</sup>C Programming Mode

The DACx3004 devices have a 2-wire serial interface (SCL and SDA), and one address pin (A0), as shown in the pin diagram in Section 5. The  $I^2C$  bus consists of a data line (SDA) and a clock line (SCL) with pullup structures. When the bus is idle, both SDA and SCL lines are pulled high. All the  $I^2C$ -compatible devices connect to the  $I^2C$  bus through the open drain I/O pins, SDA and SCL.

The I<sup>2</sup>C specification states that the device that controls communication is called a *master*, and the devices that are controlled by the master are called *slaves*. The master device generates the SCL signal. The master device also generates special timing conditions (start condition, repeated start condition, and stop condition) on the bus to indicate the start or stop of a data transfer. Device addressing is completed by the master. The master device on an I<sup>2</sup>C bus is typically a microcontroller or digital signal processor (DSP). The DACx3004 family operates as a slave device on the I<sup>2</sup>C bus. A slave device acknowledges master commands, and upon master control, receives or transmits data.

Typically, the DACx3004 family operates as a slave receiver. A master device writes to the DACx3004, a slave receiver. However, if a master device requires the DACx3004 internal register data, the DACx3004 operate as a slave transmitter. In this case, the master device reads from the DACx3004. According to I<sup>2</sup>C terminology, read and write refer to the master device.

The DACx3004 family is a slave and supports the following data transfer modes:

- Standard mode (100 kbps)
- Fast mode (400 kbps)
- Fast mode plus (1.0 Mbps)

The data transfer protocol for standard and fast modes is exactly the same; therefore, both modes are referred to as *F/S-mode* in this document. The fast mode plus protocol is supported in terms of data transfer speed, but not output current. The low-level output current would be 3 mA; similar to the case of standard and fast modes. The DACx3004 family supports 7-bit addressing. The 10-bit addressing mode is not supported. The device supports the general call reset function. Sending the following sequence initiates a software reset within the device: start or repeated start, 0x00, 0x06, stop. The reset is asserted within the device on the rising edge of the ACK bit, following the second byte.

Other than specific timing signals, the I<sup>2</sup>C interface works with serial bytes. At the end of each byte, a ninth clock cycle generates and detects an acknowledge signal. An acknowledge is when the SDA line is pulled low during the high period of the ninth clock cycle. A not-acknowledge is when the SDA line is left high during the high period of the ninth clock cycle, as shown in Figure 7-7.

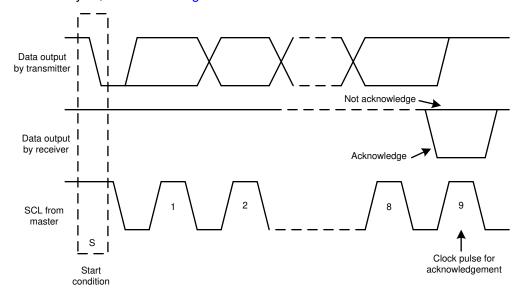


Figure 7-7. Acknowledge and Not Acknowledge on the I<sup>2</sup>C Bus



#### 7.5.2.1 F/S Mode Protocol

The following steps explain a complete transaction in F/S mode.

- 1. The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in Figure 7-8. All I<sup>2</sup>C-compatible devices recognize a start condition.
- 2. The master then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit (R/W) on the SDA line. During all transmissions, the master makes sure that data are valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse, as shown in Figure 7-9. All devices recognize the address sent by the master and compare the address to the respective internal fixed address. Only the slave device with a matching address generates an acknowledge by pulling the SDA line low during the entire high period of the 9th SCL cycle, as shown in Figure 7-7. When the master detects this acknowledge, the communication link with a slave has been established.
- 3. The master generates further SCL cycles to transmit (R/W bit 0) or receive (R/W bit 1) data to the slave. In either case, the receiver must acknowledge the data sent by the transmitter. The acknowledge signal can be generated by the master or by the slave, depending on which is the receiver. The 9-bit valid data sequences consists of 8-data bits and 1 acknowledge-bit, and can continue as long as necessary.
- 4. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low-to-high while the SCL line is high, as shown in Figure 7-8. This action releases the bus and stops the communication link with the addressed slave. All I<sup>2</sup>C-compatible devices recognize the stop condition. Upon receipt of a stop condition, the bus is released, and all slave devices then wait for a start condition followed by a matching address.

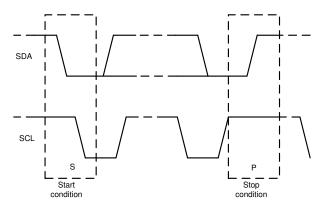


Figure 7-8. Start and Stop Conditions

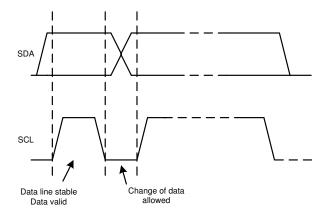


Figure 7-9. Bit Transfer on the I<sup>2</sup>C Bus



## 7.5.2.2 I<sup>2</sup>C Update Sequence

For a single update, the DACx3004 require a start condition, a valid I<sup>2</sup>C address byte, a command byte, and two data bytes, as listed in Table 7-9.

Table 7-9. Update Sequence

| MSB |                          | LSB | ACK | MSB        |                       | LSB | ACK | MSB  |           | LSB | ACK | MSB  |          | LSB | ACK |
|-----|--------------------------|-----|-----|------------|-----------------------|-----|-----|------|-----------|-----|-----|------|----------|-----|-----|
|     | ress (A) I<br>tion 7.5.2 | ,   |     |            | mmand b<br>tion 7.5.2 | ,   |     | Data | byte - M  | SDB |     | Data | byte - L | SDB |     |
| С   | DB [31:24]               |     |     | DB [23:16] |                       | i]  |     | [    | OB [15:8] | ]   |     |      | DB [7:0] |     |     |

After each byte is received, the DACx3004 family acknowledges the byte by pulling the SDA line low during the high period of a single clock pulse, as shown in Figure 7-10. These four bytes and acknowledge cycles make up the 36 clock cycles required for a single update to occur. A valid I<sup>2</sup>C address byte selects the DACx3004 devices.

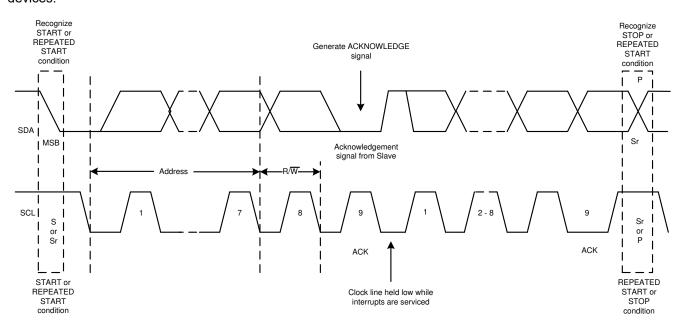


Figure 7-10. I<sup>2</sup>C Bus Protocol

The command byte sets the operating mode of the selected DACx3004 device. For a data update to occur when the operating mode is selected by this byte, the DACx3004 device must receive two data bytes: the most significant data byte (MSDB) and least significant data byte (LSDB). The DACx3004 device performs an update on the falling edge of the acknowledge signal that follows the LSDB.

When using fast mode (clock = 400 kHz), the maximum DAC update rate is limited to 10 kSPS. Using fast mode plus (clock = 1 MHz), the maximum DAC update rate is limited to 25 kSPS. When a stop condition is received, the DACx3004 device releases the  $I^2$ C bus and awaits a new start condition.



### 7.5.2.2.1 Address Byte

The address byte, as shown in Table 7-10, is the first byte received from the master device following the start condition. The first four bits (MSBs) of the address are factory preset to 1001. The next three bits of the address are controlled by the A0 pin. The A0 pin input can be connected to VDD, AGND, SCL, or SDA. The A0 pin is sampled during the first byte of each data frame to determine the address. The device latches the value of the address pin, and consequently responds to that particular address according to Table 7-11.

Table 7-10. Address Byte

| COMMENT           |     |     |     | LSB |  |     |        |     |
|-------------------|-----|-----|-----|-----|--|-----|--------|-----|
| _                 | AD6 | AD5 | AD4 | AD3 | AD2                                      | AD1 | AD0    | R/W |
| General address   | 1   | 0   | 0   | 1   | See Table 7-11<br>(slave address column) |     | 0 or 1 |     |
| Broadcast address | 1   | 0   | 0   | 0   | 1  | 1   | 1      | 0   |

The DACx3004 supports broadcast addressing, which is used for synchronously updating or powering down multiple DACx3004 devices. When the broadcast address is used, the DACx3004 responds regardless of the address pin state. Broadcast is supported only in write mode.

Table 7-11. Address Format

| SLAVE ADDRESS | A0 PIN |
|---------------|--------|
| 000           | AGND   |
| 001           | VDD    |
| 010           | SDA    |
| 011           | SCL    |

#### **7.5.2.2.2 Command Byte**

Table 7-16 lists the command byte in the ADDRESS column.



## 7.5.2.3 I<sup>2</sup>C Read Sequence

To read any register the following command sequence must be used:

- 1. Send a start or repeated start command with a slave address and the R/ $\overline{W}$  bit set to 0 for writing. The device acknowledges this event.
- 2. Send a command byte for the register to be read. The device acknowledges this event again.
- 3. Send a repeated start with the slave address and the R/ $\overline{W}$  bit set to 1 for reading. The device acknowledges this event.
- 4. The device writes the MSDB byte of the addressed register. The master must acknowledge this byte.
- 5. Finally, the device writes out the LSDB of the register.

An alternative reading method allows for reading back the value of the last register written. The sequence is a start or repeated start with the slave address and the R/ $\overline{W}$  bit set to 1, and the two bytes of the last register are read out.

The broadcast address cannot be used for reading.

### Table 7-12. Read Sequence

| S | мѕ  | SB  |                              | R/ W<br>(0) | ACK   | MSB  |                                | LSB   | ACK   | Sr | MSB         |                                | R/ W<br>(1) | ACK  | мѕв  |      | LSB    | ACK | MSB  |      | LSB    | ACK |
|---|-----|-----|------------------------------|-------------|-------|------|--------------------------------|-------|-------|----|-------------|--------------------------------|-------------|------|------|------|--------|-----|------|------|--------|-----|
|   | ,   | Se  | ORE<br>YTE<br>ectio<br>5.2.2 | n           |       | S    | MMA<br>BYTE<br>ection<br>5.2.2 | n     |       | Sr | S           | DRE<br>BYTI<br>ection<br>5.2.2 | E<br>on     |      | M    | 1SDI | В      |     | L    | .SDI | 3      |     |
|   | Fro | m N | /last                        | er          | Slave | Fron | n Ma                           | aster | Slave |    | From Master |                                | Slave       | Fror | n SI | ave  | Master | Fro | m SI | ave  | Master |     |

### 7.5.3 General-Purpose Input/Output (GPIO) Modes

Together with I<sup>2</sup>C and SPI, the DACx3004 also support a GPIO that can be configured in the NVM for multiple functions. This pin allows for updating the DAC output channels and reading status bits without using the programming interface, thus enabling processor-less operation. In the GPIO-CONFIG register, write 1 to the GPI1-EN bit to set the GPIO pin as an input, or write 1 to the GPO1-EN bit to set the pin as output. There are global and channel-specific functions mapped to the GPIO pin. For channel-specific functions, select the channels using the GPI1-CH-SEL field in the GPIO-CONFIG register. Table 7-13 lists the functional options available for the GPIO as input and Table 7-14 lists the options for the GPIO as output. Some of the GP input operations are edge-triggered after the device boots up. After the power supply ramps up, the device registers the GPI level and executes the associated command. This feature allows the user to configure the initial output state at power-on. By default, the GPIO pin is not mapped to any operation. Pull the GPIO pin to high or low when not used. When the GPIO pin is mapped to a specific input function, the corresponding software bit functionality is disabled to avoid a race condition. When used as a RESET input, the GPIO pin must transmit an active-low pulse for triggering a device reset. All other constraints of the functions are applied to the GPIO-based trigger.



Table 7-13. General-Purpose Input Function Map

|             |             | Table 7-13. | General-Purpose Input   | Function Map         |   |
|-------------|-------------|-------------|---|----------------------|---|
| REGISTER    | BIT FIELD   | VALUE       | CHANNELS  | GPIO EDGE /<br>LEVEL | FUNCTION  |
|             |             | 0000        | ٨॥  | Falling-edge         | Trigger DEEP-SLEEP mode.  |
|             |             | 0000        | All   | Rising-edge          | Bring the device out of deep-sleep.   |
|             |             | 0010        | All   | Falling-edge         | Trigger FAULT-DUMP  |
|             |             | 0010        | All   | Rising-edge          | No effect   |
|             |             | 0011        | As per GPI1-CH-SEL  | Low                  | IOUT power-down   |
|             |             | 0011        | As per of 11-off-occ  | High                 | IOUT power-up   |
|             |             | 0100        | As per GPI1-CH-SEL  | Low                  | VOUT power-down. Pulldown resistor as per the VOUT-PDN-X setting              |
|             |             |             |   | High                 | VOUT power-up   |
|             |             | 0101        | All   | Falling-edge         | Trigger PROTECT function  |
|             |             | 0101        | All   | Rising-edge          | No effect   |
|             |             | 0111        | All   | Falling-edge         | Trigger CLR function  |
|             |             | 0111        | All   | Rising-edge          | No effect   |
|             |             |             | As per GPI1-CH-SEL. Both  | Falling-edge         | Trigger LDAC function   |
| GPIO-CONFIG | GPI1-CONFIG | 1000        | the SYNC-CONFIG-X and<br>the GPI1-CH-SEL must be<br>configured for every channel. | Rising-edge          | No effect   |
|             |             | 1001        | As per GPI1-CH-SEL  | Falling-edge         | Stop function generation  |
|             |             | 1001        | As per GFTI-OII-GEL   | Rising-edge          | Start function generation   |
|             |             | 1010        | As per GPI1-CH-SEL  | Falling-edge         | Trigger margin-low  |
|             |             | 1010        | As per GFTI-CIT-SEL   | Rising-edge          | Trigger margin-high   |
|             |             | 1011        | AII   | Low pulse            | Trigger device RESET. The RESET configuration must be programmed into the NVM |
|             |             |             |   | Rising-edge          | Brings the device out of reset  |
|             | _           | 1100        | All   | Low                  | NVM programming allowed   |
|             |             | 1100        | Zui   | High                 | NVM programming blocked   |
|             |             |             |   | Low                  | Write to the register map allowed   |
|             |             | 1101        | All   | High                 | Write to the register map blocked except a write to the DEV-UNLOCK field      |
|             |             | Others      | NA  | NA                   | NA  |

# Table 7-14. General-Purpose Output (STATUS) Function Map

| REGISTER    | BIT FIELD   | VALUE  | FUNCTION   |
|-------------|-------------|--------|------------|
|             |             | 0001   | NVM-BUSY   |
|             |             | 0100   | DAC-0-BUSY |
|             |             | 0101   | DAC-1-BUSY |
|             | GPO1-CONFIG | 0110   | DAC-2-BUSY |
| GPIO-CONFIG |             | 0111   | DAC-3-BUSY |
| GPIO-CONFIG |             | 1000   | WIN-CMP-0  |
|             |             | 1001   | WIN-CMP-1  |
|             |             | 1010   | WIN-CMP-2  |
|             |             | 1011   | WIN-CMP-3  |
|             |             | Others | NA         |

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# 7.6 Register Map

Table 7-15. Register Map

| REGISTER                   |                      |                       | MOST              | SIGNIFICANT      | DATA BYTE                                      | MSDB)             |                   |                  | •                  |                   | LEAST              | SIGNIFICANT      | T DATA BYTE        | (LSDB)               |                   |                  |  |
|----------------------------|----------------------|-----------------------|-------------------|------------------|--|-------------------|-------------------|------------------|--------------------|-------------------|--------------------|------------------|--------------------|----------------------|-------------------|------------------|--|
| REGISTER                   | BIT15                | BIT14                 | BIT13             | BIT12            | BIT11  | BIT10             | ВІТ9              | BIT8             | BIT7               | BIT6              | BIT5               | BIT4             | BIT3               | BIT2                 | BIT1              | BIT0             |  |
| NOP                        |                      |                       |                   |                  |  |                   |                   | N                | NOP                |                   |                    |                  |                    |                      |                   |                  |  |
| DAC-X-MARGIN-<br>HIGH      |                      |                       |                   |                  |  | DAC-X-MA          | RGIN-HIGH         |                  |                    |                   |                    |                  |                    | Х                    |                   |                  |  |
| DAC-X-MARGIN-<br>LOW       |                      |                       |                   |                  |  | DAC-X-MA          | ARGIN-LOW         |                  |                    |                   |                    |                  |                    | x                    |                   |                  |  |
| DAC-X-VOUT-<br>CMP-CONFIG  |                      | Х                     |                   |                  | VOUT-X-GAIN                                    | I                 |                   |                  | Х                  |                   |                    | CMP-X-OD-<br>EN  | CMP-X-<br>OUT-EN   | CMP-X-HIZ-<br>IN-DIS | CMP-X-INV-<br>EN  | CMP-X-EN         |  |
| DAC-X-IOUT-MISC-<br>CONFIG |                      | Х                     |                   |                  | IOUT-X   | -RANGE            | '                 |                  |                    |                   |                    | Х                |                    |                      |                   |                  |  |
| DAC-X-CMP-<br>MODE-CONFIG  |                      | 2                     | X                 |                  | CMP-X-MODE X                                   |                   |                   |                  |                    |                   |                    |                  |                    |                      |                   |                  |  |
| DAC-X-FUNC-<br>CONFIG      | CLR-SEL-X            | SYNC-<br>CONFIG-X     | BRD-<br>CONFIG-X  |                  |  |                   |                   |                  | FUNC-G             | EN-CONFIG-        | BLOCK-X            |                  |                    |                      |                   |                  |  |
| DAC-X-DATA                 |                      |                       |                   |                  |  | DAC->             | X-DATA            |                  |                    |                   |                    |                  |                    | :                    | X                 |                  |  |
| COMMON-CONFIG              | WIN-<br>LATCH-EN     | DEV-LOCK              | EE-READ-<br>ADDR  | EN-INT-REF       | N-INT-REF VOUT-PDN-3 IOUT-PDN-3 VOUT-PDN-2 IOU |                   |                   |                  | IOUT-PDN-2         | VOUT              | -PDN-1             | IOUT-PDN-1       | VOUT-PDN-0         |                      | IOUT-PDN-0        |                  |  |
| COMMON-<br>TRIGGER         |                      | DEV-U                 | NLOCK             |                  | RESET  |                   |                   | LDAC             | CLR                | Х                 | BIT-FAULT-<br>DUMP | PROTECT          | READ-ONE-<br>TRIG  | NVM-PROG             | NVM-<br>RELOAD    |                  |  |
| COMMON-DAC-<br>TRIG        | RST-CMP-<br>FLAG-0   | TRIG-MAR-<br>LO-0     | TRIG-MAR-<br>HI-0 | START-<br>FUNC-0 | RST-CMP-<br>FLAG-1                             | TRIG-MAR-<br>LO-1 | TRIG-MAR-<br>HI-1 | START-<br>FUNC-1 | RST-CMP-<br>FLAG-2 | TRIG-MAR-<br>LO-2 | TRIG-MAR-<br>HI-2  | START-<br>FUNC-2 | RST-CMP-<br>FLAG-3 | TRIG-MAR-<br>LO-3    | TRIG-MAR-<br>HI-3 | START-<br>FUNC-3 |  |
| GENERAL-STATUS             | NVM-CRC-<br>FAIL-INT | NVM-CRC-<br>FAIL-USER | Х                 | DAC-<br>BUSY-3   | DAC-<br>BUSY-2                                 | DAC-<br>BUSY-1    | DAC-<br>BUSY-0    | NVM-BUSY         | DEVICE-ID          |                   |                    |                  |                    |                      |                   |                  |  |
| CMP-STATUS                 |                      |                       |                   | Х                |  |                   |                   | PROTECT-<br>FLAG | WIN-CMP-3          | WIN-CMP-2         | WIN-CMP-1          | WIN-CMP-0        | CMP-<br>FLAG-3     | CMP-<br>FLAG-2       | CMP-<br>FLAG-1    | CMP-<br>FLAG-0   |  |
| GPIO-CONFIG                | GF-EN                | DEEP-<br>SLEEP-EN     | GPO1-EN           |                  | GPO1-  | CONFIG            |                   |                  | GPI-C              | :H-SEL            | l                  |                  | GPI1-C             | CONFIG               | •                 | GPI1-EN          |  |
| DEVICE-MODE-<br>CONFIG     | RESE                 | RVED                  | DIS-MODE-<br>IN   |                  | RESERVED                                       |                   | PROTEC            | T-CONFIG         |                    | RESERVED          |                    |                  |                    | Х                    |                   |                  |  |
| INTERFACE-<br>CONFIG       |                      | X TIMEOUT- X EN       |                   |                  |  |                   |                   |                  |                    |                   | Х                  |                  |                    | FAST-SDO-<br>EN      | Х                 | SDO-EN           |  |
| DAC-X-DATA-8BIT            | DAC-X-DATA-8BIT      |                       |                   |                  |  |                   |                   |                  | X                  |                   |                    |                  |                    |                      |                   |                  |  |
| BRDCAST-DATA               |                      |                       |                   |                  |  | BRDCA             | ST-DATA           |                  | X                  |                   |                    |                  |                    |                      |                   |                  |  |
| PMBUS-PAGE                 |                      |                       | PMBUS-PAGE        |                  |  |                   |                   |                  |                    | NA                |                    |                  |                    |                      |                   |                  |  |
| PMBUS-OP-CMD               |                      | PMBUS-OPERATION-CMD-X |                   |                  |  |                   |                   |                  |                    | NA                |                    |                  |                    |                      |                   |                  |  |
| PMBUS-CML                  |                      |                       | )                 | X                |  |                   | CML               | Х                | NA                 |                   |                    |                  |                    |                      |                   |                  |  |
| PMBUS-VERSION              |                      |                       |                   | PMBUS-           | VERSON   |                   | •                 |                  |                    |                   |                    | N                | IA                 |                      |                   |                  |  |

NOTE: The highlighted gray cells indicate the register bits or fields that are stored in the NVM.

NOTE: X = Don't care.

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Table 7-16 Pegister Names

| I <sup>2</sup> C/SPI ADDRESS | PMBUS PAGE ADDR | PMBUS REGISTER<br>ADDR | REGISTER NAME          | SECTION        |
|------------------------------|-----------------|------------------------|------------------------|----------------|
| 00h                          | FFh             | D0h                    | NOP                    | Section 7.6.1  |
| 01h                          | 00h             | 25h                    | DAC-0-MARGIN-HIGH      | Section 7.6.2  |
| 02h                          | 00h             | 26h                    | DAC-0-MARGIN-LOW       | Section 7.6.3  |
| 03h                          | FFh             | D1h                    | DAC-0-VOUT-CMP-CONFIG  | Section 7.6.4  |
| 04h                          | FFh             | D2h                    | DAC-0-IOUT-MISC-CONFIG | Section 7.6.5  |
| 05h                          | FFh             | D3h                    | DAC-0-CMP-MODE-CONFIG  | Section 7.6.6  |
| 06h                          | FFh             | D4h                    | DAC-0-FUNC-CONFIG      | Section 7.6.7  |
| 07h                          | 01h             | 25h                    | DAC-1-MARGIN-HIGH      | Section 7.6.1  |
| 08h                          | 01h             | 26h                    | DAC-1-MARGIN-LOW       | Section 7.6.2  |
| 09h                          | FFh             | D5h                    | DAC-1-VOUT-CMP-CONFIG  | Section 7.6.3  |
| 0Ah                          | FFh             | D6h                    | DAC-1-IOUT-MISC-CONFIG | Section 7.6.4  |
| 0Bh                          | FFh             | D7h                    | DAC-1-CMP-MODE-CONFIG  | Section 7.6.5  |
| 0Ch                          | FFh             | D8h                    | DAC-1-FUNC-CONFIG      | Section 7.6.6  |
| 0Dh                          | 02h             | 25h                    | DAC-2-MARGIN-HIGH      | Section 7.6.1  |
| 0Eh                          | 02h             | 26h                    | DAC-2-MARGIN-LOW       | Section 7.6.2  |
| 0Fh                          | FFh             | D9h                    | DAC-2-VOUT-CMP-CONFIG  | Section 7.6.3  |
| 10h                          | FFh             | DAh                    | DAC-2-IOUT-MISC-CONFIG | Section 7.6.4  |
| 11h                          | FFh             | DBh                    | DAC-2-CMP-MODE-CONFIG  | Section 7.6.5  |
| 12h                          | FFh             | DCh                    | DAC-2-FUNC-CONFIG      | Section 7.6.6  |
| 13h                          | 03h             | 25h                    | DAC-3-MARGIN-HIGH      | Section 7.6.1  |
| 14h                          | 03h             | 26h                    | DAC-3-MARGIN-LOW       | Section 7.6.2  |
| 15h                          | FFh             | DDh                    | DAC-3-VOUT-CMP-CONFIG  | Section 7.6.3  |
| 16h                          | FFh             | DEh                    | DAC-3-IOUT-MISC-CONFIG | Section 7.6.4  |
| 17h                          | FFh             | DFh                    | DAC-3-CMP-MODE-CONFIG  | Section 7.6.5  |
| 18h                          | FFh             | E0h                    | DAC-3-FUNC-CONFIG      | Section 7.6.6  |
| 19h                          | 00h             | 21h                    | DAC-0-DATA             | Section 7.6.8  |
| 1Ah                          | 01h             | 21h                    | DAC-1-DATA             | Section 7.6.8  |
| 1Bh                          | 02h             | 21h                    | DAC-2-DATA             | Section 7.6.8  |
| 1Ch                          | 03h             | 21h                    | DAC-3-DATA             | Section 7.6.8  |
| 1Fh                          | FFh             | E3h                    | COMMON-CONFIG          | Section 7.6.9  |
| 20h                          | FFh             | E4h                    | COMMON-TRIGGER         | Section 7.6.10 |
| 21h                          | FFh             | E5h                    | COMMON-DAC-TRIG        | Section 7.6.11 |

**Table 7-16. Register Names (continued)** 

| I <sup>2</sup> C/SPI ADDRESS | PMBUS PAGE ADDR | PMBUS REGISTER<br>ADDR | REGISTER NAME      | SECTION        |
|------------------------------|-----------------|------------------------|--------------------|----------------|
| 22h                          | FFh             | E6h                    | GENERAL-STATUS     | Section 7.6.12 |
| 23h                          | FFh             | E7h                    | CMP-STATUS         | Section 7.6.13 |
| 24h                          | FFh             | E8h                    | GPIO-CONFIG        | Section 7.6.14 |
| 25h                          | FFh             | E9h                    | DEVICE-MODE-CONFIG | Section 7.6.15 |
| 26h                          | FFh             | EAh                    | INTERFACE-CONFIG   | Section 7.6.16 |
| 40h                          | NA              | NA                     | DAC-0-DATA-8BIT    | Section 7.6.17 |
| 41h                          | NA              | NA                     | DAC-1-DATA-8BIT    | Section 7.6.17 |
| 42h                          | NA              | NA                     | DAC-2-DATA-8BIT    | Section 7.6.17 |
| 43h                          | NA              | NA                     | DAC-3-DATA-8BIT    | Section 7.6.17 |
| 50h                          | FFh             | F1h                    | BRDCAST-DATA       | Section 7.6.18 |
| 51h                          | All pages       | 00h                    | PMBUS-PAGE         | Section 7.6.19 |
| 52h                          | 00h             | 01h                    | PMBIS-OP-CMD-0     | Section 7.6.20 |
| 53h                          | 01h             | 01h                    | PMBUS-OP-CMD-1     | Section 7.6.20 |
| 54h                          | 02h             | 01h                    | PMBUS-OP-CMD-2     | Section 7.6.20 |
| 55h                          | 03h             | 01h                    | PMBUS-OP-CMD-3     | Section 7.6.20 |
| 56h                          | All pages       | 78h                    | PMBUS-CML          | Section 7.6.21 |
| 57h                          | All pages       | 98h                    | PMBUS-VERSION      | Section 7.6.22 |

## **Table 7-17. Access Type Codes**

| Access Type            | Code | Description                            |
|------------------------|------|--|
| Х                      | Х    | Don't care                             |
| Read Type              |      |  |
| R                      | R    | Read                                   |
| Write Type             |      |  |
| W                      | W    | Write                                  |
| Reset or Default Value |      |  |
| -n                     |      | Value after reset or the default value |



#### 7.6.1 NOP Register (address = 00h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D0h

Figure 7-11. NOP Register

|    |    |    |    |    | U  |   |        |   | , |   |   |   |   |   |   |
|----|----|----|----|----|----|---|--------|---|---|---|---|---|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8      | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|    |    |    |    |    |    |   | NOP    |   |   |   |   |   |   |   |   |
|    |    |    |    |    |    |   | R/ W-0 | h |   |   |   |   |   |   |   |

Table 7-18. NOP Register Field Descriptions

| Bit    | Field | Туре | Reset | Description  |
|--------|-------|------|-------|--------------|
| 15 - 0 | NOP   | R/W  | 0000h | No operation |

#### 7.6.2 DAC-X-MARGIN-HIGH Register (address = 01h, 07h, 0Dh, 13h) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 25h

Figure 7-12. DAC-X-MARGIN-HIGH Register (X = 0, 1, 2, 3)

| 15 | 14  | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2   | 1  | 0 |
|----|---|----|----|----|----|---|---|---|---|---|---|---|-----|----|---|
|    | DAC-X-MARGIN-HIGH[11:0]<br>DAC-X-MARGIN-HIGH[9:0] |    |    |    |    |   |   |   |   |   |   | X | •   |    |   |
|    | R/ ₩-0h   |    |    |    |    |   |   |   |   |   |   |   | X-0 | )h |   |

Table 7-19. DAC-X-MARGIN-HIGH Register Field Descriptions

| Bit    | Field                   | Туре | Reset | Description   |
|--------|-------------------------|------|-------|---|
| 15 - 4 | DAC-X-MARGIN-HIGH[11:0] | R/W  | 000h  | Margin-high code for DAC output   |
|        | DAC-X-MARGIN-HIGH[9:0]  |      |       | Data are in straight-binary format. MSB left-aligned.                           |
|        |                         |      |       | Use the following bit-alignment:  |
|        |                         |      |       | DAC63004: {DAC-X-MARGIN-HIGH[11:0]}<br>DAC53004: {DAC-X-MARGIN-HIGH[9:0], X, X} |
|        |                         |      |       | X = Don't care bits.  |
| 3 - 0  | X                       | Х    | 0     | Don't care  |

#### 7.6.3 DAC-X-MARGIN-LOW Register (address = 02h, 08h, 0Eh, 14h) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 26h

Figure 7-13. DAC-X-MARGIN-LOW Register (X = 0, 1, 2, 3)

| 15 | 15 14 13 12 11 10 9 8 7 6 5 4                   |  |  |  |  |  |  |  |  |  | 3 | 3 2 1 0 |     |    |  |  |
|----|---|--|--|--|--|--|--|--|--|--|---|---------|-----|----|--|--|
|    | DAC-X-MARGIN-LOW[11:0]<br>DAC-X-MARGIN-LOW[9:0] |  |  |  |  |  |  |  |  |  |   |         | Х   |    |  |  |
|    | R/ W-0h   |  |  |  |  |  |  |  |  |  |   |         | X-C | )h |  |  |

Table 7-20. DAC-X-MARGIN-LOW Register Field Descriptions

| Bit    | Field                  | Туре | Reset | Description   |
|--------|------------------------|------|-------|---|
| 15 - 4 | DAC-X-MARGIN-LOW[11:0] | R/W  | 000h  | Margin-low code for DAC output  |
|        | DAC-X-MARGIN-LOW[9:0]  |      |       | Data are in straight-binary format. MSB left-aligned.                         |
|        |                        |      |       | Use the following bit-alignment:  |
|        |                        |      |       | DAC63004: {DAC-X-MARGIN-LOW[11:0]}<br>DAC53004: {DAC-X-MARGIN-LOW[9:0], X, X} |
|        |                        |      |       | X = Don't care bits.  |
| 3 - 0  | X                      | Х    | 0     | Don't care  |



# 7.6.4 DAC-X-VOUT-CMP-CONFIG Register (address = 03h, 09h, 0Fh, 15h) [reset = 0000h] PMBus page address = FFh, PMBus register address = D1h, D5h, D9h, DDh

Figure 7-14. DAC-X-VOUT-CMP-CONFIG Register (X = 0, 1, 2, 3)

| • | 15 | 14   | 13 | 12          | 11     | 10 | 9 | 8 | 7    | 6 | 5 | 4                   | 3                        | 2                        | 1                    | 0            |
|---|----|------|----|-------------|--------|----|---|---|------|---|---|---------------------|--------------------------|--------------------------|----------------------|--------------|
|   |    | Х    |    | VOUT-GAIN-X |        |    |   |   | Х    |   |   | CMP-<br>X-OD-<br>EN | CMP-<br>X-<br>OUT-<br>EN | CMP-X-<br>HIZ-IN-<br>DIS | CMP-<br>X-INV-<br>EN | CMP-<br>X-EN |
|   |    | X-0h |    | F           | R/W-0h |    |   |   | X-0h |   |   | R/<br>W-0h          | R/<br>W-0h               | R/W-0h                   | R/<br>W-0h           | R/<br>W-0h   |

#### Table 7-21. DAC-X-VOUT-CMP-CONFIG Register Field Descriptions

| Bit     | Field            | Туре | Reset | Description   |
|---------|------------------|------|-------|---|
| 15 - 13 | X                | X    | 0h    | Don't care  |
| 12 - 10 | VOUT-GAIN-X      | R/W  | Oh    | 000: Gain = 1x, external reference on VREF pin. 001: Gain = 1x, VDD as reference. 010: Gain = 1.5x, internal reference. 011: Gain = 2x, internal reference. 100: Gain = 3x, internal reference. 101: Gain = 4x, internal reference. Others: NA. |
| 9 - 5   | X                | X    | 0h    | Don't care  |
| 4       | CMP-X-OD-EN      | R/W  | 0     | 1: Set OUTx pin as open-drain in comparator mode (CMP-X-EN = 1 and CMP-X-OUT-EN = 1). 0: Set OUTx pin as push-pull.   |
| 3       | CMP-X-OUT-EN     | R/W  | 0     | Bring comparator output to the respective OUTx pin.     Generate comparator output but consume internally.  |
| 2       | CMP-X-HIZ-IN-DIS | R/W  | 0     | FBx input has high-impedance. Input voltage range is limited.     FBx input is connected to resistor divider and has finite impedance. Input voltage range is same as full-scale.   |
| 1       | CMP-X-INV-EN     | R/W  | 0     | Invert the comparator output.     Don't invert the comparator output.   |
| 0       | CMP-X-EN         | R/W  | 0     | Enable comparator mode. Current-output must be in power-down.     Disable comparator mode.  |

# 7.6.5 DAC-X-IOUT-MISC-CONFIG Register (address = 04h, 0Ah, 10h, 16h) [reset = 0000h] PMBus page address = FFh, PMBus register address = D2h, D6h, DAh, DEh

Figure 7-15. DAC-X-IOUT-MISC-CONFIG Register (X = 0, 1, 2, 3)

| 15           | 14 | 13   | 12           | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------------|----|------|--------------|----|----|---|---|---|---|---|---|---|---|---|---|
|              | Х  |      | IOUT-RANGE-X |    |    | X |   |   |   |   |   |   |   |   |   |
| X-0h R/ W-0h |    | X-0h |              |    |    |   |   |   |   |   |   |   |   |   |   |

Table 7-22. DAC-X-IOUT-MISC-CONFIG Register Field Descriptions

| Bit     | Field        | Туре | Reset | Description  |
|---------|--------------|------|-------|--|
| 15 - 13 | x            | Х    | 0h    | Don't care.  |
| 12 - 9  | IOUT-RANGE-X | R/W  | 0000  | 0000: 0 μA to 25 μA<br>0001: 0 μA to 50 μA<br>0010: 0 μA to 125 μA<br>0011: 0 μA to 250 μA<br>0100: -24 μA to 0 μA<br>0101: -48 μA to 0 μA<br>0110: -120 μA to 0 μA<br>0111: -240 μA to 0 μA<br>1000: -25 μA to +25 μA<br>1001: -50 μA to +50 μA<br>1011: -250 μA to +250 μA<br>0111: -250 μA to +250 μA |
| 8 - 0   | X            | Х    | 000h  | Don't care.  |

# 7.6.6 DAC-X-CMP-MODE-CONFIG Register (address = 05h, 0Bh, 11h, 17h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D3h, D7h, DBh, DFh

Figure 7-16. DAC-X-CMP-MODE-CONFIG Register (X = 0, 1, 2, 3)

| 15 | 1/1  | 13 | 12  | 11    | 10      | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|------|----|-----|-------|---------|---|---|---|---|---|---|---|---|---|---|
|    |      | Х  |     | CMP-X | -MODE   |   |   |   |   |   | Χ |   |   |   |   |
|    | X-0h |    | R/W | 7-0h  | Oh X-0h |   |   |   |   |   |   |   |   |   |   |

Table 7-23. DAC-X-CMP-MODE-CONFIG Register Field Descriptions

| Bit     | Field      | Type | Reset | Description  |
|---------|------------|------|-------|--|
| 15 - 12 | Х          | Х    | 00h   | Don't care.  |
| 11 - 10 | CMP-X-MODE | R/W  | 00    | 00: No hysteresis or window function. 01: Hysteresis provided using DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers. 10: Window comparator mode with DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers setting window bounds. 11: Invalid setting. |
| 9 - 0   | Х          | Х    | 000h  | Don't care.  |



# 7.6.7 DAC-X-FUNC-CONFIG Register (address = 06h, 0Ch, 12h, 18h) [reset = 0000h] PMBus page address = FFh, PMBus register address = D4h, D8h, DCh, E0h

Figure 7-17. DAC-X-FUNC-CONFIG Register (X = 0, 1, 2, 3) for Linear Slew-Rate Setting

| 15        | 14                | 13               | 12                    | 12 11 10 9 8 7 6 5 4 3 2 |  |  |  |  |  |  | 1 | 0 |
|-----------|-------------------|------------------|-----------------------|--------------------------|--|--|--|--|--|--|---|---|
| CLR-SEL-X | SYNC-<br>CONFIG-X | BRD-<br>CONFIG-X | FUNC-GEN-CONFIG-BLOCK |                          |  |  |  |  |  |  |   |   |
| R/ W-0h   | R/ W-0h           | R/ W-0h          | R/ W-0h               |                          |  |  |  |  |  |  |   |   |

#### Table 7-24. DAC-X-FUNC-CONFIG Register Field Descriptions

| Bit | Field         | Туре | Reset | Description  |
|-----|---------------|------|-------|--|
| 15  | CLR-SEL-X     | R/W  | 0     | 0: Clear DAC-X to zero-scale. 1: Clear DAC-X to mid-scale.   |
| 14  | SYNC-CONFIG-X | R/W  | 0     | 0: DAC-X output updates immediately after a write command. 1: DAC-X output updates with LDAC pin falling-edge or when the LDAC bit in the COMMON-TRIGGER register is set to 1. |
| 13  | BRD-CONFIG-X  | R/W  | 0     | 0: Don't update DAC-X with broadcast command. 1: Update DAC-X with broadcast command.  |

#### Table 7-25. Linear-Slew Mode: FUNC-GEN-CONFIG-BLOCK Field Descriptions

| Bit     | Field         | Туре | Reset | Description  |
|---------|---------------|------|-------|--|
| 12 - 11 | PHASE-SEL-X   | R/W  | 0     | 00: 0 degree.<br>01: 120 degree.<br>10: 240 degree.<br>11: 90 degree.  |
| 10 - 8  | FUNC-CONFIG-X | R/W  | 0     | 000: Triangular wave. 001: Sawtooth wave. 010: Inverse sawtooth wave. 100: Sine wave. 111: Disable function generation. Others: Invalid.   |
| 7       | LOG-SLEW-EN-X | R/W  | 0     | 0: Enable linear slew.   |
| 6 - 4   | CODE-STEP-X   | R/W  | 0     | CODE-STEP for linear-slew mode: 000: 1-LSB. 001: 2-LSB. 010: 3-LSB. 011: 4-LSB. 100: 6-LSB. 101: 8-LSB. 111: 32-LSB.   |
| 3 - 0   | SLEW-RATE-X   | R/W  | 0     | SLEW-RATE for logarithmic-slew mode: 0000: No slew for margin-high and margin-low. Invalid for waveform generation. 0001: 4 µs/step. 0010: 8 µs/step. 0011: 12 µs/step. 0100: 18 µs/step. 0101: 27.04 µs/step. 0101: 40.48 µs/step. 0111: 60.72 µs/step. 1000: 91.12 µs/step. 1001: 136.72 µs/step. 1010: 239.2 µs/step. 1011: 418.64 µs/step. 1110: 2563.92 µs/step. 1111: 5127.92 µs/step. |



### Table 7-26. Logarithmic-Slew Mode: FUNC-GEN-CONFIG-BLOCK Field Descriptions

| Bit     | Field         | Туре | Reset | Description   |
|---------|---------------|------|-------|---|
| 12 - 11 | PHASE-SEL-X   | R/W  | 0     | 00: 0 degree.<br>01: 120 degree.<br>10: 240 degree.<br>11: 90 degree.   |
| 10 - 8  | FUNC-CONFIG-X | R/W  | 0     | 000: Triangular wave. 001: Sawtooth wave. 010: Inverse sawtooth wave. 100: Sine wave. 111: Disable function generation. Others: Invalid.  |
| 7       | LOG-SLEW-EN-X | R/W  | 0     | 1: Enable logarithmic slew.   |
| 6 - 4   | RISE-SLEW-X   | R/W  | 0     | SLEW-RATE for log-slew mode: 000: 4 µs/step. 001: 12 µs/step. 010: 27.04 µs/step. 011: 60.72 µs/step. 100: 136.72 µs/step. 101: 418.64 µs/step. 110: 1282 µs/step. 111: 5127.92 µs/step.  |
| 3 - 1   | FALL-SLEW-X   | R/W  | 0     | SLEW-RATE for log-slew mode: 000: 4 µs/step. 001: 12 µs/step. 010: 27.04 µs/step. 010: 136.72 µs/step. 100: 136.72 µs/step. 101: 418.64 µs/step. 110: 1282 µs/step. 111: 5127.92 µs/step. |
| 0       | Х             | Х    | 0     | Don't care.   |

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# 7.6.8 DAC-X-DATA Register (address = 19h, 1Ah, 1Bh, 1Ch) [reset = 0000h]

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PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 21h

Figure 7-18. DAC-X-DATA Register (X = 0, 1, 2, 3)

| 15                                  | 14      | 13 | 12 11 10 9 8 7 6 5 4 |  |  |  |  |  |  | 3 | 2 | 1   | 0  |  |
|-------------------------------------|---------|----|----------------------|--|--|--|--|--|--|---|---|-----|----|--|
| DAC-X-DATA[11:0]<br>DAC-X-DATA[9:0] |         |    |                      |  |  |  |  |  |  |   | Х | ,   |    |  |
|                                     | R/ ₩-0h |    |                      |  |  |  |  |  |  |   |   | X-0 | )h |  |

#### Table 7-27. DAC-X-DATA Register Field Descriptions

| Bit    | Field                               | Туре | Reset | Description   |
|--------|-------------------------------------|------|-------|---|
| 15 - 4 | DAC-X-DATA[11:0]<br>DAC-X-DATA[9:0] | R/W  | 000h  | Data for DAC output Data are in straight-binary format. MSB left-aligned. MSB left- aligned. Use the following bit-alignment: DAC63004: {DAC-X-DATA[11:0]} DAC53004: {DAC-X-DATA[9:0], X, X} X = Don't care bits. |
| 3 - 0  | Х                                   | Х    | 0h    | Don't care.   |

#### 7.6.9 COMMON-CONFIG Register (address = 1Fh) [reset = 0FFFh]

PMBus page address = FFh, PMBus register address = E3h

#### Figure 7-19. COMMON-CONFIG Register

| 15                          | 14           | 13               | 12             | 11     | 10   | 9              | 8      | 7    | 6              | 5     | 4     | 3              | 2     | 1     | 0              |
|-----------------------------|--------------|------------------|----------------|--------|------|----------------|--------|------|----------------|-------|-------|----------------|-------|-------|----------------|
| WINDO<br>W-<br>LATCH-<br>EN | DEV-<br>LOCK | EE-READ-<br>ADDR | EN-INT-<br>REF | VOUT-P | DN-3 | IOUT-<br>PDN-3 | VOUT-P | DN-2 | IOUT-<br>PDN-2 | VOUT- | PDN-1 | IOUT-<br>PDN-1 | VOUT- | PDN-0 | IOUT-<br>PDN-0 |
| R/ W-0h                     | R/ W-0h      | R/ W-0h          | R/ W-0h        | R/ W-  | -0h  | R/<br>₩-0h     | R/ W-  | 0h   | R/<br>₩-0h     | R/ ₹  | 7-0h  | R/<br>₩-0h     | R/ W  | 7-0h  | R/<br>W-0h     |

#### Table 7-28. COMMON-CONFIG Register Field Descriptions

| B.,                                |                 |      |       | 1 togistor i loid Bocomptiono   |
|------------------------------------|-----------------|------|-------|---|
| Bit                                | Field           | Type | Reset | Description   |
| 15                                 | WINDOW-LATCH-EN | R/W  | 0     | Non-latching window-comparator output.     Latching window-comparator output  |
| 14                                 | DEV-LOCK        | R/W  | 0     | 0 : Device not locked 1: Device locked, the device locks all the registers. To set this bit back to 0 (unlock device), write to the unlock code to the DEV-UNLOCK field in the COMMON-TRIGGER register first, followed by a write to the DEV-LOCK bit as 0. |
| 13                                 | EE-READ-ADDR    | R/W  | 0     | 0: Fault-dump read enable at address 0x00. 1: Fault-dump read enable at address 0x01.   |
| 12                                 | EN-INT-REF      | R/W  | 000   | Disable internal reference     Enable internal reference. This bit must be set before using internal reference gain settings.   |
| 11 - 10, 8 -<br>7, 5 - 4, 2 -<br>1 | VOUT-PDN-X      | R/W  | 11    | 00: Power-up VOUT-X. 01: Power-down VOUT-X with 10 KΩ to AGND. 10: Power-down VOUT-X with 100 KΩ to AGND. 11: Power-down VOUT-X with Hi-Z to AGND.  |
| 9, 6, 3, 0                         | IOUT-PDN-X      | R/W  | 1     | 0: Power-up IOUT-X.<br>1: Power-down IOUT-X   |



#### 7.6.10 COMMON-TRIGGER Register (address = 20h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E4h

Figure 7-20. COMMON-TRIGGER Register

|  | 15               | 14   | 13   | 12 | 11      | 10  | 9 | 8              | 7          | 6                     | 5            | 4              | 3       | 2          | 1       | 0 |
|--|------------------|------|------|----|---------|-----|---|----------------|------------|-----------------------|--------------|----------------|---------|------------|---------|---|
|  | DEV-UNLOCK RESET |      |      |    | LDAC    | CLR | Х | FAULT-<br>DUMP | PROTECT    | READ-<br>ONE-<br>TRIG | NVM-<br>PROG | NVM-<br>RELOAD |         |            |         |   |
|  |                  | R/ ₩ | √-0h |    | R/ ₩-0h |     |   | R/<br>₩-0h     | R/<br>₩-0h | X-0h                  | R/<br>W-0h   | R/ W̄-0h       | R/ W-0h | R/<br>W-0h | R/ W-0h |   |

#### Table 7-29. COMMON-TRIGGER Register Field Descriptions

| Bit     | Field         | Туре | Reset | Description   |
|---------|---------------|------|-------|---|
| 15 - 12 | DEV-UNLOCK    | R/W  | 0000  | 0101: Device unlocking password. Others: Don't care.  |
| 11 - 8  | RESET         | W    | 0000  | 1010 : POR reset triggered. This field is self-resetting. Others: Don't care.   |
| 7       | LDAC          | R/W  | 0     | 0: LDAC operation not triggered. 1: LDAC operation triggered if the respective SYNC-CONFIG-X bit in the DAC-X-FUNC-CONFIG register is 1. This bit is self-resetting.                                    |
| 6       | CLR           | R/W  | 0     | 0: DAC registers and outputs unaffected. 1: DAC registers and outputs set to zero-code or mid-code based on the respective CLR-SEL-X bit in the DAC-X-FUNC-CONFIG register. This bit is self-resetting. |
| 5       | X             | Х    | 0     | Don't care.   |
| 4       | FAULT-DUMP    | R/W  | 0     | Fault-dump is not triggered.     Triggers fault-dump sequence. This bit is self-resetting.  |
| 3       | PROTECT       | R/W  | 0     | 0: PROTECT function not triggered. 1: Trigger PROTECT function. This bit is self-resetting.   |
| 2       | READ-ONE-TRIG | R/W  | 0     | Fault-dump read not triggered.     Read one row of NVM for fault-dump. This bit is self-resetting.  |
| 1       | NVM-PROG      | R/W  | 0     | NVM write not triggered.     NVM write triggered. This bit is self-resetting.   |
| 0       | NVM-RELOAD    | R/W  | 0     | O: NVM reload not triggered. I: Reload data from NVM to register map. This bit is self-resetting.   |

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#### 7.6.11 COMMON-DAC-TRIG Register (address = 21h) [reset = 0000h]

#### PMBus page address = FFh, PMBus register address = E5h

#### Figure 7-21. COMMON-DAC-TRIG Register

| 15                       | 14                    | 13                | 12               | 11                           | 10                    | 9                     | 8                    | 7                            | 6                     | 5                     | 4                    | 3                            | 2                 | 1                     | 0                    |
|--------------------------|-----------------------|-------------------|------------------|------------------------------|-----------------------|-----------------------|----------------------|------------------------------|-----------------------|-----------------------|----------------------|------------------------------|-------------------|-----------------------|----------------------|
| RESET-<br>CMP-<br>FLAG-0 | TRIG-<br>MAR-<br>LO-0 | TRIG-MAR-<br>HI-0 | START-<br>FUNC-0 | RESET<br>-CMP-<br>FLAG-<br>1 | TRIG-<br>MAR-<br>LO-1 | TRIG-<br>MAR-<br>HI-1 | START-<br>FUNC-<br>1 | RESET<br>-CMP-<br>FLAG-<br>2 | TRIG-<br>MAR-<br>LO-2 | TRIG-<br>MAR-<br>HI-2 | START-<br>FUNC-<br>2 | RESET<br>-CMP-<br>FLAG-<br>2 | TRIG-<br>MAR-LO-3 | TRIG-<br>MAR-<br>HI-3 | START-<br>FUNC-<br>3 |
| W-0h                     | W-0h                  | W-0h              | R/W-0h           | W-0h                         | W-0h                  | W-0h                  | R/W-0h               | W-0h                         | W-0h                  | W-0h                  | R/W-0h               | W-0h                         | W-0h              | W-0h                  | R/W-0h               |

#### Table 7-30. COMMON-DAC-TRIG Register Field Descriptions

| Bit              | Field            | Туре | Reset | Description   |
|------------------|------------------|------|-------|---|
| 15 , 11, 7,<br>3 | RESET-CMP-FLAG-X | W    | 0     | Comparator output unaffected.     Reset latching-comparator output. This bit is self-resetting.                     |
| 14, 10, 6,<br>2  | TRIG-MAR-LO-X    | W    | 0     | 0: Don't care. 1: Trigger margin-low command. This bit is self-resetting.   |
| 13, 9, 5, 1      | TRIG-MAR-HI-X    | W    | 0     | 0: Don't care. 1: Trigger margin-high command. This bit is self-resetting.  |
| 12, 8, 4, 0      | START-FUNC-X     | R/W  | 0     | Stop function generation.     Start function generation as per FUNC-GEN-CONFIG-X in the DAC-X-FUNC-CONFIG register. |



#### 7.6.12 GENERAL-STATUS Register (address = 22h) [reset = TBD]

PMBus page address = FFh, PMBus register address = E6h

#### Figure 7-22. GENERAL-STATUS Register

| 15                           | 14                            | 13   | 12             | 11             | 10             | 9              | 8    | 7 | 6 | 5 | 4   | 3      | 2 | 1 | 0 |
|------------------------------|-------------------------------|------|----------------|----------------|----------------|----------------|------|---|---|---|-----|--------|---|---|---|
| NVM-<br>CRC-<br>FAIL-<br>INT | NVM-<br>CRC-<br>FAIL-<br>USER | Х    | DAC-3-<br>BUSY | DAC-2-<br>BUSY | DAC-1-<br>BUSY | DAC-0-<br>BUSY | X    |   |   |   | DEV | ICE-ID |   |   |   |
| R-0h                         | R-0h                          | R-0h | R-0h           | R-0h           | R-0h           | R-0h           | X-0h |   |   |   | R   | -0h    |   |   |   |

#### Table 7-31. GENERAL-STATUS Register Field Descriptions

| Bit   | Field             | Туре | Reset | Description   |
|-------|-------------------|------|-------|---|
| 15    | NVM-CRC-FAIL-INT  | R    | 0     | 0: No CRC error in OTP. 1: Indicates a failure in OTP loading. A software reset or power-cycle can bring the device out of this condition in case of temporary failure.   |
| 14    | NVM-CRC-FAIL-USER | R    | 0     | O: No CRC error in NVM loading.  1: Indicates a failure in NVM loading. The register settings are corrupted. The device allows all operations during this error condition. Reprogram the NVM to get original state. A software reset brings the device out of this temporary error condition. |
| 13    | X                 | R    | 0     | Don't care.   |
| 12    | DAC-3-BUSY        | R    | 0     | 0: DAC-3 channel can accept commands. 1: DAC-3 channel doesn't accept commands.   |
| 11    | DAC-2-BUSY        | R    | 0     | 0: DAC-2 channel can accept commands. 1: DAC-2 channel doesn't accept commands.   |
| 10    | DAC-1-BUSY        | R    | 0     | 0: DAC-1 channel can accept commands. 1: DAC-1 channel doesn't accept commands.   |
| 9     | DAC-0-BUSY        | R    | 0     | 0: DAC-0 channel can accept commands. 1: DAC-0 channel doesn't accept commands.   |
| 8     | X                 | R    | 0     | Don't care  |
| 7 - 0 | DEVICE-ID         | R    |       | Device identifier:<br>DAC53004: 24h<br>DAC63004: 34h  |

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#### 7.6.13 CMP-STATUS Register (address = 23h) [reset = 0000h]

#### PMBus page address = FFh, PMBus register address = E7h

#### Figure 7-23. CMP-STATUS Register

| 15 | 14 | 13 | 12   | 11 | 10 | 9 | 8        | 7     | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
|----|----|----|------|----|----|---|----------|-------|-------|-------|-------|-------|-------|-------|-------|
|    |    |    | X    |    |    |   | PROTECT- | WIN-  | WIN-  | WIN-  | WIN-  | CMP-  | CMP-  | CMP-  | CMP-  |
|    |    |    |      |    |    |   | FLAG     | CMP-3 | CMP-2 | CMP-1 | CMP-0 | FLAG- | FLAG- | FLAG- | FLAG- |
|    |    |    |      |    |    |   |          |       |       |       |       | 3     | 2     | 1     | 0     |
|    |    |    | X-0h |    |    |   | R-0h     | R-0h  | R-0h  | R-0h  | R-0h  | R-0h  | R-0h  | R-0h  | R-0h  |

**Table 7-32. CMP-STATUS Register Field Descriptions** 

| Bit        | Field        | Туре | Reset | Description   |
|------------|--------------|------|-------|---|
| 15 - 9     | Х            | Х    | 0     | Don't care.   |
| 8          | PROTECT-FLAG | R    | 0     | 0 : PROTECT operation not triggred or in progress. 1: PROTECT function is completed. This bit resets to 0 when read.                                      |
| 7, 6, 5, 4 | WIN-CMP-X    | R    | 0     | Window comparator output from respective channels. The output is latched or unlatched based on the WINDOW-LATCH-EN setting in the COMMON-CONFIG register. |
| 3, 2, 1, 0 | CMP-FLAG-X   | R    | 0     | Synchronized comparator output from respective channels.  |

#### 7.6.14 GPIO-CONFIG Register (address = 24h) [reset = 0000h]

#### PMBus page address = FFh, PMBus register address = E8h

#### Figure 7-24. GPIO-CONFIG Register

|         |                       |             |    | ,       | _     |   | <u></u> |         |        |   |   |         |       |   |         |  |
|---------|-----------------------|-------------|----|---------|-------|---|---------|---------|--------|---|---|---------|-------|---|---------|--|
| 15      | 14                    | 13          | 12 | 11      | 10    | 9 | 8       | 7       | 6      | 5 | 4 | 3       | 2     | 1 | 0       |  |
| GF-EN   | DEEP-<br>SLEEP-<br>EN | GPO1-<br>EN | C  | SPO1-C  | ONFIG |   |         | GPI1-0  | CH-SEL |   |   | GPI1-C  | ONFIG |   | GPI1-EN |  |
| R/ W-0h | R/ W-0h               | R/ W-0h     |    | R/ ₩-0h |       |   |         | R/ W-0h |        |   |   | R/ W-0h |       |   |         |  |

#### Table 7-33. GPIO-CONFIG Register Field Descriptions

| Bit Field Type Reset Description |               |      |       |   |  |  |  |  |  |  |  |
|----------------------------------|---------------|------|-------|---|--|--|--|--|--|--|--|
| Bit                              | Field         | Type | Reset | Description   |  |  |  |  |  |  |  |
| 15                               | GF-EN         | R/W  | 0     | O: Glitch filter disabled for GP input. This setting provides faster response.  1: Glitch filter enabled for GP input. This setting introduces additional propagation delay but provides robustness.  |  |  |  |  |  |  |  |
| 14                               | DEEP-SLEEP-EN | R/W  | 0     | Deep-sleep mode disabled.     Deep-sleep mode enabled for GP input.   |  |  |  |  |  |  |  |
| 13                               | GPO1-EN R/V   |      | 0     | Disable output mode for GPIO pin.     Enable output mode for GPIO pin.  |  |  |  |  |  |  |  |
| 12 - 9                           | GPO1-CONFIG   | R/W  | 0000  | STATUS function setting. The GPIO pin is mapped to the following register bits as output:  0001: NVM-BUSY 0100: DAC-0-BUSY 0101: DAC-1-BUSY 0110: DAC-2-BUSY 0111: DAC-3-BUSY 1000: WIN-CMP-0 1001: WIN-CMP-1 1010: WIN-CMP-2 1011:WIN-CMP-3 Others: NA |  |  |  |  |  |  |  |



#### Table 7-33. GPIO-CONFIG Register Field Descriptions (continued)

| Bit   | Field       | Туре | Reset | Descriptions (continued)   |
|-------|-------------|------|-------|--|
|       |             |      |       | ·  |
| 8 - 5 | GPI1-CH-SEL | R/W  | 0000  | Each bit corresponds to a DAC channel. 0b is disabled and 1b is enabled.  GPI1-CH-SEL[0]: Channel 0 GPI1-CH-SEL[1]: Channel 1 GPI1-CH-SEL[2]: Channel 2 GPI1-CH-SEL[3]: Channel 3  |
|       |             |      |       | Example: when GPI1-CH-SEL is 0101, both channel-0 and channel-2 are enabled and both channel-1 and channel-3 are disabled.   |
| 4 - 1 | GPI1-CONFIG | R/W  | 0000  | GPIO pin input configuration. Global settings act on the entire device. Channel-specific settings are dependent on the channel selection by the GPI1-CH-SEL bits:  |
|       |             |      |       | 0000: DEEP-SLEEP (global). GPIO falling-edge triggers deep-sleep mode, GPIO rising-edge takes the device out of deep-sleep mode.   |
|       |             |      |       | 0010: FAULT-DUMP (global). GPIO falling-edge triggers fault-dump, GPIO = 1 has no effect.  |
|       |             |      |       | 0011: IOUT power-up, down (channel-specific). GPIO = 0 is power-down, GPIO = 1 is power-up.  |
|       |             |      |       | 0100: VOUT power-up/down (channel-specific). The output load is as per the VOUT-PDN-X setting. GPIO = 0 is power-down, GPIO = 1 is power-up.   |
|       |             |      |       | 0101: PROTECT input (global). GPIO falling-edge asserts PROTECT function, GPIO = 1 has no effect.  |
|       |             |      |       | 0111: $\overline{\text{CLR}}$ input (global). GPIO = 0 asserts $\overline{\text{CLR}}$ function, GPIO = 1has no effect.  |
|       |             |      |       | 1000: \overline{LDAC} input (channel-specific). GPIO falling-edge asserts \overline{LDAC} function, GPIO = 1 has no effect. Both the SYNC-CONFIGX and the GPI1-CH-SEL must be configured for every channel.  |
|       |             |      |       | 1001: Start, stop function generation (channel-specific). GPIO falling-edge stops function generation. GPIO rising-edge starts function generation.  |
|       |             |      |       | 1010: Trigger margin-high, low (channel-specific). GPIO falling-edge triggers margin-low. GPIO rising-edge triggers margin-high.   |
|       |             |      |       | 1011:RESET input (global). The falling-edge of the GPIO pin asserts the RESET function. The RESET input must be a pulse. The GPIO rising-edge brings the device out of reset. The RESET configuration must be programmed into the NVM. Otherwise the setting will be cleared after the device reset. |
|       |             |      |       | 1100: NVM write-protection (global). GPIO falling-edge allows NVM programming. GPIO = 1 blocks NVM programming.  |
|       |             |      |       | 1101: Register-map lock (global). GPIO = 0 allows update to the register map. GPIO = 1 blocks any register map update except a write to the DEV-UNLOCK field.  Others: NA  |
| 0     | GPI1-EN     | R/W  | 0     | 0: Disable input mode for GPIO pin. 1: Enable input mode for GPIO pin.   |

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#### 7.6.15 DEVICE-MODE-CONFIG Register (address = 25h) [reset = 0000h]

#### PMBus page address = FFh, PMBus register address = E9h

Figure 7-25. DEVICE-MODE-CONFIG Register

| 15  | 14              | 13              | 12 | 11              | 10   | 9    | 8             | 7       | 6      | 5  | 4 | 3    | 2 | 1 | 0 |
|-----|-----------------|-----------------|----|-----------------|------|------|---------------|---------|--------|----|---|------|---|---|---|
| RES | ERVED           | DIS-<br>MODE-IN | RE | SERVED          | )    |      | TECT-<br>NFIG | R       | ESERVE | ĒD |   |      | Х |   |   |
| R/  | R/ W-0h R/ W-0h |                 | F  | R/ <b>W</b> -0h | R/ ₹ | ∇-0h |               | R/ W-0h | 1      |    |   | X-0h |   |   |   |

#### Table 7-34. DEVICE-MODE-CONFIG Register Field Descriptions

| Bit     | Field          | Туре | Reset | Description  |
|---------|----------------|------|-------|--|
| 15 - 14 | RESERVED       | R/W  | 00    | Always write 0b00.   |
| 13      | DIS-MODE-IN    | R/W  | 0     | Always write 1.  |
| 12 - 10 | RESERVED       | R/W  | 0     | Always write 0b000.  |
| 9 - 8   | PROTECT-CONFIG | R/W  | 00    | 00: Switch to power-down (no slew). 01: Switch to DAC code stored in NVM (no slew) and then switch to power-down. 10: Slew to margin-low code and then switch to power-down. 11: Slew to margin-high code and then switch to power-down. |
| 7 - 5   | RESERVED       | R/W  | 0     | Always write 0b000.  |
| 4 - 0   | Х              | R/W  | 00h   | Don't care.  |

#### 7.6.16 INTERFACE-CONFIG Register (address = D1h) [reset = 0000h]

Figure 7-26. INTERFACE-CONFIG Register

|    |      |    |                |    | J    | - |              |   |   |      |   |   |             |      |            |
|----|------|----|----------------|----|------|---|--------------|---|---|------|---|---|-------------|------|------------|
| 15 | 14   | 13 | 12             | 11 | 10   | 9 | 8            | 7 | 6 | 5    | 4 | 3 | 2           | 1    | 0          |
|    | Х    |    | TIMEOUT-<br>EN |    | Х    |   | EN-<br>PMBUS |   |   | Х    |   |   | FSDO-<br>EN | Х    | SDO-<br>EN |
|    | X-0h |    | R/ W̄-0h       |    | X-0h |   | R/ W-0h      |   |   | X-0h |   |   | R/ W-0h     | X-0h | R/<br>₩-0h |

#### Table 7-35, INTERFACE-CONFIG Register Field Descriptions

|         | Table 7 00. INTERNACE CONTINUES TICIA DESCRIPTIONS |      |       |   |  |  |  |  |  |  |  |  |
|---------|--|------|-------|---|--|--|--|--|--|--|--|--|
| Bit     | Field  | Туре | Reset | Description   |  |  |  |  |  |  |  |  |
| 15 - 13 | X  | Х    | 0h    | Don't care.   |  |  |  |  |  |  |  |  |
| 12      | TIMEOUT-EN   | R/W  | 0     | 0: I <sup>2</sup> C timeout disabled.<br>1: I <sup>2</sup> C timeout enabled. |  |  |  |  |  |  |  |  |
| 11 - 9  | X  | Х    | 0h    | Don't care.   |  |  |  |  |  |  |  |  |
| 8       | EN-PMBUS   | R/W  | 0     | 0: PMBus disabled.<br>1: Enable PMBus.  |  |  |  |  |  |  |  |  |
| 7 - 3   | X  | Х    | 00h   | Don't care.   |  |  |  |  |  |  |  |  |
| 2       | FSDO-EN  | R/W  | 0     | 0: Fast SDO disabled.<br>1: Fast SDO enabled.                                 |  |  |  |  |  |  |  |  |
| 1       | X  | Х    | 0     | Don't care.   |  |  |  |  |  |  |  |  |
| 0       | SDO-EN   | R/W  | 0     | 0: SDO disabled. 1: SDO enabled on GPIO pin.                                  |  |  |  |  |  |  |  |  |



#### 7.6.17 DAC-X-DATA-8BIT Register (address = 40h, 41h, 42h, 43h) [reset = 0000h]

PMBus page address = Not applicable, PMBus register address = Not applicable

Figure 7-27. DAC-X-DATA-8BIT Register

| 15                   | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3    | 2 | 1 | 0 |
|----------------------|----|----|----|----|----|---|---|---|---|---|---|------|---|---|---|
| DAC-X-DATA-8BIT[7:0] |    |    |    |    |    |   |   |   |   |   |   | X    |   |   |   |
| R/ W-0h              |    |    |    |    |    |   |   |   |   |   | > | (-0h |   |   |   |

Table 7-36. DAC-X-DATA-8BIT Register Field Descriptions

| Bit    | Field                | Туре | Reset | Description   |
|--------|----------------------|------|-------|---|
| 15 - 8 | DAC-X-DATA-8BIT[7:0] | R/W  |       | 8-bit data for current output. This register provides faster update rate. Data are in straight-binary format. |
| 7 - 0  | X                    | X    | 00h   | Don't care.   |

#### 7.6.18 BRDCAST-DATA Register (address = 50h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = F1h

#### Figure 7-28. BRDCAST-DATA Register

| 15 | 14                                      | 13 | 13 12 11 10 9 8 7 6 5 4 |  |  |  |  |  |  | 3 | 2 | 1   | 0  |  |
|----|---|----|-------------------------|--|--|--|--|--|--|---|---|-----|----|--|
|    | BRDCAST-DATA[11:0]<br>BRDCAST-DATA[9:0] |    |                         |  |  |  |  |  |  |   |   | Х   |    |  |
|    | R/ W̄-0h                                |    |                         |  |  |  |  |  |  |   |   | X-C | )h |  |

#### Table 7-37. BRDCAST-DATA Register Field Descriptions

| Bit    | Field                                   | Туре | Reset | Description  |
|--------|---|------|-------|--|
| 15 - 4 | BRDCAST-DATA[11:0]<br>BRDCAST-DATA[9:0] | R/W  |       | Broadcast code for all DAC channels Data are in straight-binary format. MSB left-aligned. Use the following bit-alignment: DAC63004: {BRDCAST-DATA[11:0]} DAC53004: {BRDCAST-DATA[9:0], X, X} X = Don't care bits. The BRD-CONFIG-X bit in the DAC-X-FUNC-CONFIG register must be enabled for the respective channels. |
| 3 - 0  |   | X    | 0h    | Don't care.  |

#### 7.6.19 PMBUS-PAGE Register (address = 51h) [reset = 0000h]

PMBus page address = X, PMBus register address = 00h

#### Figure 7-29. PMBUS-PAGE Register

| 15       | 14 | 13 | 12    | 11     | 10 | 9 | 8 | 7 | 6 | 5 | 4   | 3   | 2 | 1 | 0 |
|----------|----|----|-------|--------|----|---|---|---|---|---|-----|-----|---|---|---|
|          |    |    | PMBUS | S-PAGE |    |   |   |   |   |   | >   | <   |   |   |   |
| R/ W-00h |    |    |       |        |    |   |   |   |   |   | X-0 | )0h |   |   |   |

#### Table 7-38. PMBUS\_OPERATION Register Field Descriptions

| Bit    | Field      | Туре | Reset | Description               |
|--------|------------|------|-------|---------------------------|
| 15 - 8 | PMBUS-PAGE | R/W  | 00h   | 8-bit PMBus page address. |
| 7 - 0  | X          | Х    | 00h   | Not applicable.           |

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#### 7.6.20 PMBUS-OP-CMD-X Register (address = 52h, 53h, 54h, 55h) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 01h

Figure 7-30. PMBUS-OP-CMD-X Register (X = 0, 1, 2, 3)

|    |    |      |         | _       |       |   |   |   | _ | • |     | ,  |   |   |   |
|----|----|------|---------|---------|-------|---|---|---|---|---|-----|----|---|---|---|
| 15 | 14 | 13   | 12      | 11      | 10    | 9 | 8 | 7 | 6 | 5 | 4   | 3  | 2 | 1 | 0 |
|    |    | PMBU | IS-OPER | ATION-0 | CMD-X |   |   |   |   |   | >   | (  |   |   |   |
|    |    |      | R/W     | -00h    |       |   |   |   |   |   | X-0 | 0h |   |   |   |

Table 7-39. PMBUS-OP-CMD-X Register Field Descriptions

|        | 10010 1 0011 111      |      | J 7   | togictor i lora Bocomptionio   |
|--------|-----------------------|------|-------|--|
| Bit    | Field                 | Туре | Reset | Description  |
| 15 - 8 | PMBUS-OPERATION-CMD-X | R/W  |       | PMBus operation commands: 00h: Turn off . 80h: Turn on. A4h: Margin high, DAC output margins high to DAC-X-MARGIN-HIGH code. 94h: Margin low, DAC output margins low to DAC-X-MARGIN-LOW code. |
| 7 - 0  | Х                     | Х    | 00h   | Not applicable.  |

#### 7.6.21 PMBUS-CML Register (address = 56h) [reset = 0000h]

PMBus page address = X, PMBus register address = 78h

#### Figure 7-31. PMBUS-CML Register

| 15 | 14 | 13  | 12  | 11 | 10 | 9      | 8    | 7 | 6 | 5 | 4   | 3  | 2 | 1 | 0 |
|----|----|-----|-----|----|----|--------|------|---|---|---|-----|----|---|---|---|
|    |    | >   | X   |    |    | CML    | Χ    |   |   |   | N   | Α  |   |   |   |
|    |    | X-0 | 00h |    |    | R/W-0h | X-0h |   |   |   | X-C | 0h |   |   |   |

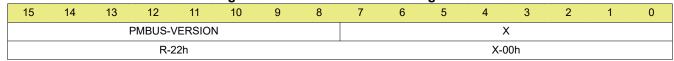
#### Table 7-40. PMBUS-CML Register Field Descriptions

| Bit     | Field | Туре | Reset | Description   |
|---------|-------|------|-------|---|
| 15 - 10 | X     | X    | 00h   | Don't care.   |
| 9       | CML   | R/W  |       | O: No communication fault.  1: PMBus communication fault for write with incorrect number of clocks, read before write command, invalid command address, and invalid or unsupported data value; reset this bit by writing 1. |
| 8       | X     | X    | 0h    | Don't care.   |
| 7 - 0   | X     | Х    | 00h   | Not applicable  |

#### 7.6.22 PMBUS-VERSION Register (address = 57h) [reset = 2200h]

PMBus page address = X, PMBus register address = 98h

#### Figure 7-32. PMBUS-VERSION Register



#### Table 7-41. PMBUS-VERSION Register Field Descriptions

| Bit    | Field         | Туре | Reset | Description     |
|--------|---------------|------|-------|-----------------|
| 15 - 8 | PMBUS-VERSION | R    | 22h   | PMBus version.  |
| 7 - 0  | X             | Х    | 00h   | Not applicable. |



#### 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 8.1 Application Information

The DACx3004 are quad-channel buffered, force-sense output, voltage-output and current-output smart DACs that include an NVM and internal reference, and available in a tiny 3-mm × 3-mm package. In voltage-output mode, short the OUTx and FBx pins for each channel. In current-output mode, leave the FBx pins unconnected. The FBx pins function as inputs in comparator mode. The external reference must not exceed VDD, either during transient or steady-state conditions. For the best Hi-Z output performance, use a pullup resistor on the VREF pin to VDD. In case the VDD remains floating during the off condition, place a 100-kΩ resistor to AGND for proper detection of the VDD off condition. All the digital outputs are open drain; use external pullup resistors on these pins. The interface protocol is detected at power-on, and the device locks to the protocol as long as VDD is on. In I²C mode, when allocating the I²C addresses in the system, consider the broadcast address as well. I²C timeout can be enabled for robustness. SPI mode is 3-wire by default. Configure the GPIO pin as SDO in the NVM for SPI readback capability. The SPI clock speed in readback mode is slower than that in write mode. Power-down mode sets the DAC outputs in Hi-Z by default. Change the configuration appropriately for different power-down settings. The DAC channels can also power-up with a programmed DAC code in the NVM.

#### 8.2 Typical Application

A power-supply margining and scaling circuit is used to trim, scale, or test the output of a power converter. This example circuit is used to test a system by margining the power supplies for adaptive voltage scaling or to program a desired value at the output. Adjustable power supplies, such as low dropout regulators (LDOs) and DC/DC converters, provide a feedback or adjust the input that is used to set the desired output. A precision voltage-output DAC is the best choice for controlling the power-supply output linearly. Figure 8-1 shows a control circuit for a switch-mode power supply (SMPS) using the DACx3004. Typical applications of power-supply margining are communications equipment, enterprise servers, test and measurement, and general-purpose power-supply modules.

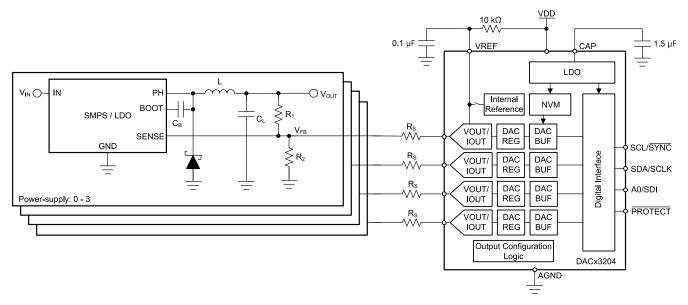


Figure 8-1. Voltage Margining and Scaling



#### 8.2.1 Design Requirements

**Table 8-1. Design Parameters** 

|   | <b>U</b>                         |
|---|----------------------------------|
| PARAMETER   | VALUE                            |
| Power-supply nominal output                               | 3.3 V                            |
| Reference voltage of the converter (V <sub>FB</sub> )     | 0.6 V                            |
| Margin  | ±10% (that is, 2.97 V to 3.63 V) |
| DAC output range  | 1.8 V                            |
| Nominal current through R <sub>1</sub> and R <sub>2</sub> | 100 μΑ                           |

#### 8.2.2 Detailed Design Procedure

The DACx3004 features a Hi-Z power-down mode that is set by default at power-up, unless the device is programmed otherwise using the NVM. When the DAC output is at Hi-Z, the current through  $R_3$  is zero and the SMPS is set at the nominal output voltage of 3.3 V. To have the same nominal condition when the DAC powers up, bring up the device at the same output as  $V_{FB}$  (that is 0.6 V). This configuration makes sure there is no current through  $R_3$  even at power-up. Calculate  $R_1$  as  $(V_{OUT} - V_{FB}) / 100 \,\mu\text{A} = 27 \,k\Omega$ .

To achieve  $\pm 10\%$  margin-high and margin-low conditions, the DAC must sink or source additional current through R<sub>1</sub>. Calculate the current from the DAC (I<sub>MARGIN</sub>) using Equation 9 as 12  $\mu$ A.

$$I_{MARGIN} = \left(\frac{V_{OUT} \times (1 + MARGIN) - V_{FB}}{R_1}\right) - I_{NOMINAL}$$
(9)

#### where

- I<sub>MARGIN</sub> is the margin current sourced or sinked from the DAC.
- MARGIN is the percentage margin value divided by 100.
- I<sub>NOMINAL</sub> is the nominal current through R<sub>1</sub> and R<sub>2</sub>.

To calculate the value of  $R_3$ , first decide the DAC output range, and make sure to avoid the codes near zero-scale and full-scale for safe operation in the linear region. A DAC output of 20 mV is a safe consideration as the minimum output, and (1.8 V - 0.6 V - 20 mV = 1.18 V) as the maximum output. When the DAC output is at 20 mV, the power supply goes to margin high, and when the DAC output is at 1.18 V, the power supply goes to margin low. Calculate the value of  $R_3$  using Equation 10 as 48.3 k $\Omega$ . Choose a standard resistor value and adjust the DAC outputs. Choosing  $R_3$  = 47 k $\Omega$  makes the DAC margin high code as 1.164 V and the DAC margin low code as 36 mV.

$$R_3 = \frac{\left|V_{DAC} - V_{FB}\right|}{I_{MARGIN}} \tag{10}$$

When the DACx3004 are set in the current-output mode, the series resistor  $R_3$  is not required. Set the DAC output at the current-output range of –25  $\mu$ A to +25  $\mu$ A, and set the DAC code appropriately to achieve a margin current of ±12  $\mu$ A.

The DACx3004 have a slew-rate feature that is used to toggle between margin high, margin low, and nominal outputs with a defined slew rate. See Section 7.6.7 for the slew-rate setting details.

#### Note

The DAC-X-MARGIN-HIGH register value in DACx3004 results in the *margin-low* value at the power supply output. Similarly, the DAC-X-MARGIN-LOW register value in DACx3004 results in the *margin-high* value at the power-supply output.



#### 9 Power Supply Recommendations

The DACx3004 family of devices does not require specific power-supply sequencing. These devices require a single power supply,  $V_{DD}$ . However, make sure the external voltage reference is applied after VDD. Use a 0.1- $\mu$ F decoupling capacitor for the  $V_{DD}$  pin. Use a bypass capacitor with a value approximately 1.5  $\mu$ F for the CAP pin.

#### 10 Layout

#### 10.1 Layout Guidelines

The DACx3004 pin configuration separates the analog, digital, and power pins for an optimized layout. For signal integrity, separate the digital and analog traces, and place decoupling capacitors close to the device pins.

#### 10.2 Layout Example

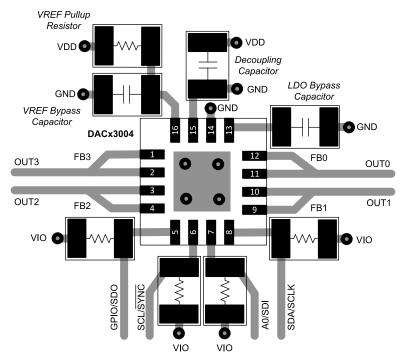


Figure 10-1. Layout Example

Note: The ground and power planes have been omitted for clarity. Connect the thermal pad to ground.



#### 11 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

#### 11.1 Documentation Support

#### 11.1.1 Related Documentation

#### 11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 11.4 Trademarks

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#### 11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 Glossary

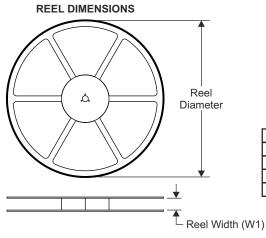
This glossary lists and explains terms, acronyms, and definitions.

#### 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



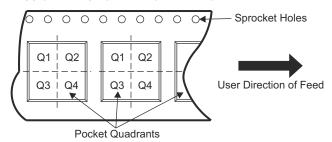
#### **Tape and Reel Information**



# TAPE DIMENSIONS KO P1 BO W Cavity A0

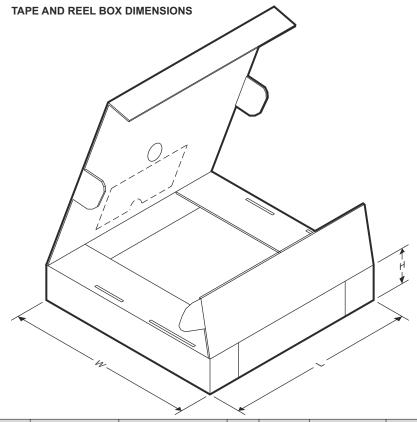
| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |
|    |   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| Device       | Package<br>Type | Package<br>Drawing | Pins | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width W1<br>(mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|--------------|-----------------|--------------------|------|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| DAC53004RTER | WQFN            | RTE                | 16   | 3000 | 330                      | 12.4                     | 3.3        | 3.3        | 1.1        | 8          | 12        | Q2               |
| DAC63004RTER | WQFN            | RTE                | 16   | 3000 | 330                      | 12.4                     | 3.3        | 3.3        | 1.1        | 8          | 12        | Q2               |

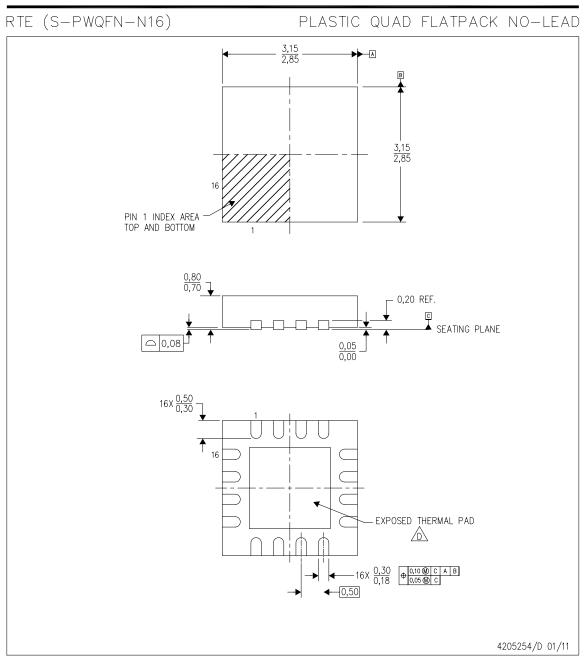




| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DAC53004RTER | WQFN         | RTE             | 16   | 3000 | 367         | 367        | 35          |
| DAC63004RTER | WQFN         | RTE             | 16   | 3000 | 367         | 367        | 35          |



#### **MECHANICAL DATA**



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No-leads (QFN) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- E. Falls within JEDEC MO-220.





#### THERMAL PAD MECHANICAL DATA

#### RTE (S-PWQFN-N16)

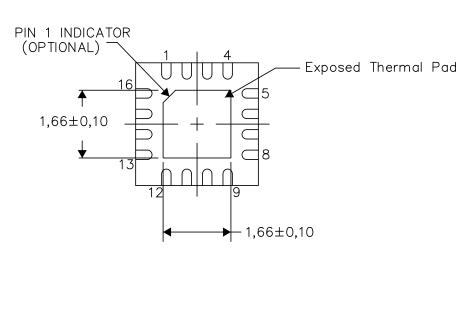
#### PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206446-8/U 08/15

NOTE: A. All linear dimensions are in millimeters

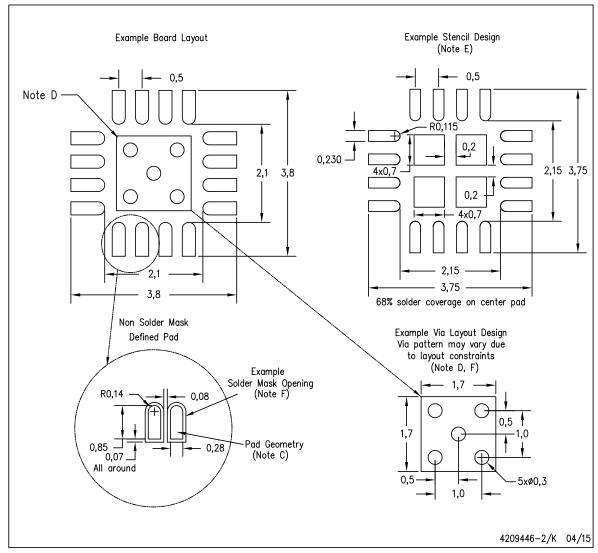




#### **LAND PATTERN DATA**

RTE (S-PWQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



www.ti.com 30-Apr-2021

#### **PACKAGING INFORMATION**

| Orderable Device | Status  | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan                | Lead finish/<br>Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|---------|--------------|--------------------|------|----------------|-------------------------|-------------------------------|---------------|--------------|-------------------------|---------|
| DAC53004RTET     | PREVIEW | WQFN         | RTE                | 16   | 250            | TBD                     | Call TI                       | Call TI       | -40 to 125   |                         |         |
| PDAC63004RTET    | ACTIVE  | WQFN         | RTE                | 16   | 250            | Non-RoHS &<br>Non-Green | Call TI                       | Call TI       | -40 to 125   |                         | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL. Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# RTE (S-PWQFN-N16)

## PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

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- E. Falls within JEDEC MO-220.



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